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Report No.: SHEM180100007601

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## TEST REPORT

**Application No.:** SHEM1801000076IT  
**Applicant:** ZHEJIANG DAHUA VISION TECHNOLOGY CO.,LTD  
**Address of Applicant:** No.1199 Bin'an Road, Binjiang District, Hangzhou,P.R.China  
**Manufacturer:** ZHEJIANG DAHUA VISION TECHNOLOGY CO.,LTD  
**Address of Manufacturer:** No.1199 Bin'an Road, Binjiang District, Hangzhou,P.R.China  
**Factory:** 1, ZHEJIANG DAHUA VISION TECHNOLOGY CO.,LTD  
2, ZHEJIANG DAHUA ZHILIAN CO.,LTD  
**Address of Factory:** 1, No.1199 Bin'an Road, Binjiang District, Hangzhou,P.R.China  
2, No.28, Dongqiao Road, Dongzhou Street, Fuyang District, Hangzhou,  
P.R.China.

### Equipment Under Test (EUT):

**EUT Name:** IP CAMERA

**Model No.:** DH-IPC-HUM4231P, DH-IPC-HUM7236, IPC-HUM7236, DH-IPC-HUM4231N, IPC-HUM4231P, IPC-HUM4231N, DH-IPC-HUM4231, IPC-HUM4231;□

□

Please refer to section 2 of this report which indicates which model was actually tested and which were electrically identical.

**Trade mark:**



**Standard(s) :**

EN 55032:2015 (Class B), EN 61000-3-2:2014,  
EN 61000-3-3:2013, EN 55024:2010 +A1:2015,  
EN 50130-4:2011 +A1:2014

**Date of Receipt:**

2018-01-03

**Date of Test:**

2018-01-08 to 2018-01-10

**Date of Issue:**

2018-01-15

**Test Result:**

**Pass\***

\* In the configuration tested, the EUT complied with the standards specified above.

The CE mark as shown below can be used, under the responsibility of the manufacturer, after completion of an EU Declaration of Conformity and compliance with all relevant EU Directives.



Parlam Zhan  
E&E Section Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

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Revision Record				
Version	Chapter	Date	Modifier	Remark
01	/	2018-01-15	/	Original

Authorized for issue by:				
		Bruce Tang		
		Bruce Tang /Project Engineer		
		Zenger Zhang		
		Zenger Zhang /Reviewer		

## 2 Test Summary

Emission Part				
Item	Standard	Method	Requirement	Result
Conducted Emissions at Mains Terminals (150kHz-30MHz)	EN 55032:2015	EN 55032:2015	Class B	Pass
Asymmetric Mode Conducted Emissions (150kHz-30MHz)	EN 55032:2015	EN 55032:2015	Class B	Pass
Radiated Emissions (30MHz-1GHz)	EN 55032:2015	EN 55032:2015	Class B	Pass
Radiated Emissions (above 1GHz)	EN 55032:2015	EN 55032:2015	Class B	Pass
Harmonic Current Emission	EN 61000-3-2:2014	EN 61000-3-2:2014	Class A	N/A
Voltage Fluctuations and Flicker	EN 61000-3-3:2013	EN 61000-3-3:2013	Clause 5 of EN 61000-3-3	Pass

N/A: Please refer to Section 6.5 of this report for details

<b>Immunity Part</b>				
<b>Item</b>	<b>Standard</b>	<b>Method</b>	<b>Requirement</b>	<b>Result</b>
Electrostatic Discharge	EN 55024:2010 +A1:2015	EN 61000-4-2:2009	4kV Contact Discharge 8kV Air Discharge	Pass
Electrostatic Discharge	EN 50130-4:2011 +A1:2014	EN 61000-4-2:2009	6kV Contact Discharge 2,4,8kV Air Discharge	Pass
Radiated Immunity (80MHz-1GHz)	EN 55024:2010 +A1:2015	EN 61000-4-3:2006 +A1:2008+A2:2010	3V/m, 80%, 1kHz Amp. Mod.	Pass
Radiated Immunity (80MHz-2.7GHz)	EN 50130-4:2011 +A1:2014	EN 61000-4-3:2006 +A1:2008+A2:2010	10V/m, 80%, 1kHz sinusoidal Amp. Mod.	Pass
Electrical Fast Transients/Burst at Power Port	EN 55024:2010 +A1:2015	EN 61000-4-4:2012	1kV 5/50ns Tr/Td 5kHz Repetition Frequency	Pass
Electrical Fast Transients/Burst at Power Port	EN 50130-4:2011 +A1:2014	EN 61000-4-4:2012	2kV 5/50ns Tr/Td 100kHz Repetition Frequency	Pass
Electrical Fast Transients/Burst at Signal Port	EN 55024:2010 +A1:2015	EN 61000-4-4:2012	0.5kV 5/50ns Tr/Td 5kHz Repetition Frequency	Pass
Electrical Fast Transients/Burst at Signal Port	EN 50130-4:2011 +A1:2014	EN 61000-4-4:2012	1kV 5/50ns Tr/Td 100kHz Repetition Frequency	Pass
Surge at Power Port	EN 55024:2010 +A1:2015	EN 61000-4-5:2014	1.2/50µs Tr/Td 1kV Line to Line 2kV Line to Ground	Pass
Surge at Power Port	EN 50130-4:2011 +A1:2014	EN 61000-4-5:2014	1.2/50µs Tr/Td 0.5,1kV Line to Line 0.5,1,2kV Line to Ground	Pass
Surge at Signal Port	EN 55024:2010 +A1:2015	EN 61000-4-5:2014	1.2/50µs Tr/Td 1kV Line to Ground	Pass
Surge at Signal Port	EN 50130-4:2011 +A1:2014	EN 61000-4-5:2014	1.2/50µs Tr/Td 0.5,1kV Line to Ground	Pass
Conducted Immunity at Power Port (150kHz-80MHz)	EN 55024:2010 +A1:2015	EN 61000-4-6:2014	3Vrms (emf),80%,1kHz Amp. Mod.	Pass



<b>Immunity Part</b>				
<b>Item</b>	<b>Standard</b>	<b>Method</b>	<b>Requirement</b>	<b>Result</b>
Conducted Immunity at Signal Port (150kHz-80MHz)	EN 55024:2010 +A1:2015	EN 61000-4-6:2014	3Vrms (emf),80%,1kHz Amp. Mod.	Pass
Conducted Immunity at Power Port (150kHz-100MHz)	EN 50130-4:2011 +A1:2014	EN 61000-4-6:2014	10Vrms (emf),80%,1kHz sinusoidal Amp. Mod.	Pass
Conducted Immunity at Signal Port (150kHz-100MHz)	EN 50130-4:2011 +A1:2014	EN 61000-4-6:2014	10Vrms (emf),80%,1kHz sinusoidal Amp. Mod.	Pass
Voltage Dips and Interruptions	EN 55024:2010 +A1:2015	EN 61000-4-11:2004	0 % UT for 0.5per 0 % UT for 250per 70 % UT for 25per UT is Supply Voltage	Pass
Voltage Dips and Interruptions	EN 50130-4:2011 +A1:2014	EN 61000-4-11:2004	80 % UT for 250per 70 % UT for 25per 40 % UT for 10per 0 % UT for 250per UT is Supply Voltage	Pass
Mains Supply Voltage Variations-Conditioning	EN 50130-4:2011 +A1:2014	EN 50130-4:2011+A1:2014	Unom+10% Unom-15%	Pass

<b>InternalSource</b>	<b>UpperFrequency</b>
Below 108MHz	1GHz
108MHz to 500MHz	2GHz
500MHz to 1GHz	5GHz
Above 1GHz	5 times the highest frequency or 6 GHz, whichever is less

**Declaration of EUT Family Grouping:**

There are series models mentioned in this report and they are the similar in electrical and electronic characters. Only the model DH-IPC-HUM4231P was tested since their differences are pixel.

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## 4 General Information

### 4.1 Details of E.U.T.

Power supply: DC12V  
Cable: signal cable : 0.5m

### 4.2 Description of Support Units

The EUT has been tested as an independent unit.

### 4.3 Measurement Uncertainty

No.	Item	Measurement Uncertainty
1	Conducted Emission at mains port using AMN	3.2dB (9kHz to 150kHz)
		3.0dB (150kHz to 30MHz)
2	Conducted Emission at mains port using VP	1.9 dB(9kHz to 30MHz)
3	Conducted Emission at telecommunication port using AAN	2.4 dB(150kHz to 30MHz)
4	Radiated Power	3.5dB
5	Radiated emission	4.4dB (30MHz-1GHz )
		4.6dB (1GHz-6GHz )

#### 4.4 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. E&E Lab

588 West Jindu Road, Xinqiao, Songjiang, 201612 Shanghai, China

Tel: +86 21 6191 5666 Fax: +86 21 6191 5678

No tests were sub-contracted.

#### 4.5 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **CNAS (No. CNAS L0599)**

CNAS has accredited SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

- **Industry Canada (IC) – IC Assigned Code: 8617A**

The 3m Semi-anechoic chamber of SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 8617A-1.

- **VCCI (Member No.: 3061)**

The 3m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-3868,C-4336,T-2221,G-830 respectively.

#### 4.6 Deviation from Standards

None

#### 4.7 Abnormalities from Standard Conditions

None

#### 4.8 Monitoring of EUT for All Immunity Test

Visual: work status and video quality

## 5 Equipment List

<b>Conducted Emissions at Mains Terminals (150kHz-30MHz)</b>					
<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No</b>	<b>Inventory No</b>	<b>Cal Date</b>	<b>Cal Due Date</b>
EMI test receiver	Rohde & Schwarz	ESR7	SHEM162-1	2017-12-26	2018-12-25
Line impedance stabilization network	SCHWARZBECK	NSLK8127	SHEM061-1	2017-05-17	2018-05-16
Line impedance stabilization network	EMCO	3816/2	SHEM019-1	2017-12-26	2018-12-25
Pulse limiter	Rohde & Schwarz	ESH3-Z2	SHEM029-1	2017-08-01	2018-07-31
Shielding Room	ZHONGYU	8*4*3M	SHEM079-2	2016-12-29	2019-12-28
CE test Cable	/	/	CE01	2017-12-26	2018-12-25

<b>Asymmetric Mode Conducted Emissions (150kHz-30MHz)</b>					
<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No</b>	<b>Inventory No</b>	<b>Cal Date</b>	<b>Cal Due Date</b>
EMI test receiver	Rohde & Schwarz	ESR7	SHEM162-1	2017-12-26	2018-12-25
Line impedance stabilization network	SCHWARZBECK	NSLK8127	SHEM061-1	2017-05-17	2018-05-16
8-wire ISN cat 5	SCHWARZBECK	CAT5 8158	SHEM137-1	2017-12-26	2018-12-25
8-wire ISN cat 3	SCHWARZBECK	CAT3 8158	SHEM137-2	2017-12-26	2018-12-25
8-wire ISNcat 6	SCHWARZBECK	NTFM8158	SHEM137-3	2017-12-26	2018-12-25
2-Draht ISN	Schwarzbeck - Mess-Elektronik	NTFM 8131	SHEM139-1	2017-12-26	2018-12-25
CE test Cable	/	/	CE01	2017-12-26	2018-12-25

<b>Radiated Emissions (30MHz-1GHz)</b>					
<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No</b>	<b>Inventory No</b>	<b>Cal Date</b>	<b>Cal Due Date</b>
EMI test receiver	Rohde & Schwarz	ESU40	SHEM051-1	2017-09-26	2018-09-25
CONTROLLER	INNCO	CO200	SHEM047-1	N/A	N/A
ANTENNA MAST	INNCO	MA400-EP	SHEM047-2	N/A	N/A
TURN DEVICE	INNCO	DE 3600-RH	SHEM047-3	N/A	N/A
Broadband UHF-VHF ANTENNA	SCHWARZBECK	VULB9168	SHEM048-1	2017-02-28	2020-02-27
Semi/Fully Anechoic	ST	11*6*6M	SHEM078-2	2017-07-22	2018-07-21
Low Amplifier	CLAVIO	BDLNA-0001-412010	SHEM164-1	2017-08-22	2018-08-21

<b>Radiated Emissions (above 1GHz)</b>					
<b>Equipment</b>	<b>Manufacturer</b>	<b>Model No</b>	<b>Inventory No</b>	<b>Cal Date</b>	<b>Cal Due Date</b>
EMI test receiver	Rohde & Schwarz	ESU40	SHEM051-1	2017-09-26	2018-09-25
CONTROLLER	INNCO	CO200	SHEM047-1	N/A	N/A
ANTENNA MAST	INNCO	MA400-EP	SHEM047-2	N/A	N/A
TURN DEVICE	INNCO	DE 3600-RH	SHEM047-3	N/A	N/A
Double ridged broadband horn ANTENNA	SCHWARZBECK	BBHA9120D	SHEM050-1	2017-01-14	2020-01-13
High-amplifier	SCHWARZBECK	SCU-F0118-G40-BZ4-CS	SHEM050-2	2017-01-14	2020-01-13
Semi/Fully Anechoic	ST	11*6*6M	SHEM078-2	2017-07-22	2018-07-21





Voltage Fluctuations and Flicker					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Harmonic&Flicker analyzer	AMETEK	PACS-1	SHEM024-2	2017-08-22	2018-08-21
AC Power Source 5KVA	AMETEK	5001iX	SHEM025-2	2017-08-22	2018-08-21

Electrostatic Discharge					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Electrostatic Discharge Simulator	TESEQ	NSG 437	SHEM041-1	2017-09-26	2018-09-25

Radiated Immunity (80MHz-1GHz)					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Signal generator	Rohde & Schwarz	SMJ100A	SHEM141-1	2017-09-26	2018-09-25
Power Meter	Rohde & Schwarz	NRP	SHEM057-1	2017-12-26	2018-12-25
Power meter sensor	Rohde & Schwarz	NRP-Z91	SHEM057-2	2017-12-26	2018-12-25
Antenna	SCHWARZBECK	STLP9128D	SHEM130-1	N/A	N/A
Amplifier	MILMEGA	AS0840-55-55	SHEM133-1	N/A	N/A
Power meter sensor	Rohde & Schwarz	NRP-Z22	SHEM136-1	2017-07-22	2018-07-21
ElectroMagnetic Field Probe	ETS-Lindgren	HI-6113	SHEM134-1	2017-09-07	2018-09-06
Semi/Fully Anechoic	ST	11*6*6M	SHEM078-2	2017-07-22	2018-07-21

Radiated Immunity(80MHz-2.7GHz)					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Signal generator	Rohde & Schwarz	SMJ100A	SHEM141-1	2017-09-26	2018-09-25
Power Meter	Rohde & Schwarz	NRP	SHEM057-1	2017-12-26	2018-12-25
Power meter sensor	Rohde & Schwarz	NRP-Z91	SHEM057-2	2017-12-26	2018-12-25
Antenna	SCHWARZBECK	STLP9128D	SHEM130-1	N/A	N/A
Antenna	SCHWARZBECK	STLP9149	SHEM131-1	N/A	N/A
Amplifier	MILMEGA	80RF1000-250	SHEM132-1	N/A	N/A
Amplifier	MILMEGA	AS0840-55-55	SHEM133-1	N/A	N/A
Power meter sensor	Rohde & Schwarz	NRP-Z22	SHEM136-1	2017-07-22	2018-07-21
ElectroMagnetic Field Probe	ETS-Lindgren	HI-6113	SHEM134-1	2017-09-07	2018-09-06
Semi/Fully Anechoic	ST	11*6*6M	SHEM078-2	2017-07-22	2018-07-21

Electrical Fast Transients/Burst at Power Port					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Immunity Test System	EMC PARTNER	TRA3000 F-S-D-V	SHEM163-1	2017-12-26	2018-12-25

Electrical Fast Transients/Burst at Signal Port					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Immunity Test System	EMC PARTNER	TRA3000 F-S-D-V	SHEM163-1	2017-12-26	2018-12-25
Capacitive coupling clamp	EM test	HFK	SHEM026-2	2017-08-12	2018-08-11





Data coupling network 4 line	EM test	CNV 504	SHEM026-3	2017-08-12	2018-08-11
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Surge at Power Port					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Immunity Test System	EMC PARTNER	TRA3000 F-S-D-V	SHEM163-1	2017-12-26	2018-12-25

Surge at Signal Port					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Immunity Test System	EMC PARTNER	TRA3000 F-S-D-V	SHEM163-1	2017-12-26	2018-12-25
Data coupling network 4 line	EM test	CNV 504	SHEM026-3	2017-08-12	2018-08-11

Conducted Immunity at Power Port (150kHz-80MHz)					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Signal generator	Rohde & Schwarz	SMJ100A	SHEM141-1	2017-09-26	2018-09-25
PAMP Conducted RF test system	HAEFFLY	PAMP250	SHEM023-1	2017-12-26	2018-12-25
6dB Attenuator	HUAXIANG	TST-150-761	SHEM151-1	N/A	N/A
Coupling clamp	LIITHI	EM 101	SHEM027-1	2015-05-03	2018-05-02
CDN impedance and K-factor	LUTHI	L-801 M1	SHEM023-5	2017-12-26	2018-12-25
CDN impedance and K-factor	LUTHI	L-801 M2/M3	SHEM023-6	2017-12-26	2018-12-25
Shielding Room	ZHONGYU	5*5*3M	SHEM079-6	2016-12-29	2019-12-28

Conducted Immunity at Signal Port (150kHz-80MHz)					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Signal generator	Rohde & Schwarz	SMJ100A	SHEM141-1	2017-09-26	2018-09-25
PAMP Conducted RF test system	HAEFFLY	PAMP250	SHEM023-1	2017-12-26	2018-12-25
6dB Attenuator	HUAXIANG	TST-150-761	SHEM151-1	N/A	N/A
Coupling clamp	LIITHI	EM 101	SHEM027-1	2015-05-03	2018-05-02
Shielding Room	ZHONGYU	5*5*3M	SHEM079-6	2016-12-29	2019-12-28

Conducted Immunity at Power Port (150kHz-100MHz)					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Signal generator	Rohde & Schwarz	SMJ100A	SHEM141-1	2017-09-26	2018-09-25
PAMP Conducted RF test system	HAEFFLY	PAMP250	SHEM023-1	2017-12-26	2018-12-25
6dB Attenuator	HUAXIANG	TST-150-761	SHEM151-1	N/A	N/A
CDN impedance and K-factor	LUTHI	L-801 M1	SHEM023-5	2017-12-26	2018-12-25
CDN impedance and K-factor	LUTHI	L-801 M2/M3	SHEM023-6	2017-12-26	2018-12-25
Shielding Room	ZHONGYU	5*5*3M	SHEM079-6	2016-12-29	2019-12-28



Conducted Immunity at Signal Port (150kHz-100MHz)					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Signal generator	Rohde & Schwarz	SMJ100A	SHEM141-1	2017-09-26	2018-09-25
PAMP Conducted RF test system	HAEFFLY	PAMP250	SHEM023-1	2017-12-26	2018-12-25
6dB Attenuator	HUAXIANG	TST-150-761	SHEM151-1	N/A	N/A
Coupling clamp	LIITHI	EM 101	SHEM027-1	2015-05-03	2018-05-02
CDN impedance and K-factor	LUTHI	L-801 M1	SHEM023-5	2017-12-26	2018-12-25
CDN impedance and K-factor	LUTHI	L-801 M2/M3	SHEM023-6	2017-12-26	2018-12-25

Voltage Dips and Interruptions					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Immunity Test System	EMC PARTNER	TRA3000 F-S-D-V	SHEM163-1	2017-12-26	2018-12-25

Mains Supply Voltage Variations-Conditioning					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Immunity Test System	EMC PARTNER	TRA3000 F-S-D-V	SHEM163-1	2017-12-26	2018-12-25

General used equipment					
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
Digital pressure meter	YONGZHI	DYM3-01	SHEM082-1	2017-03-03	2018-03-02
Temperature&humidity recorder	ShangHai weather meter work	ZJ 1-2B	SHEM042-1~6	2017-09-13	2018-09-12
Digital Multimeter	FLUKE	17B	SHEM043-5	2017-09-13	2018-09-12
Autoformer regulator	Guangzhou bao de	TDGC2-5KVA	SHEM150-1	N/A	N/A
Multi-purpose tong tester	FLUKE	316	SHEM001-1	2017-01-29	2018-01-28

## 6 Emission Test Results

### 6.1 Conducted Emissions at Mains Terminals (150kHz-30MHz)

Test Requirement:	EN 55032:2015
Test Method:	EN 55032:2015
Frequency Range:	150kHz to 30MHz
Limit:	
0.15M-0.5MHz	66dB(μV)-56dB(μV) quasi-peak, 56dB(μV)-46dB(μV) average
0.5M-5MHz	56dB(μV) quasi-peak, 46dB(μV) average
5M-30MHz	60dB(μV) quasi-peak, 50dB(μV) average
Detector:	Peak for pre-scan (9kHz resolution bandwidth) 0.15M to 30MHz

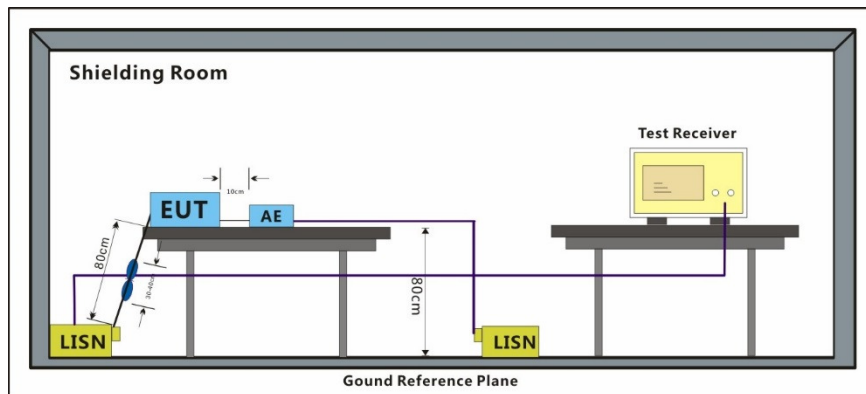
#### 6.1.1 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 48 % RH Atmospheric Pressure: 1010 mbar

Test mode a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

#### 6.1.2 Test Setup Diagram

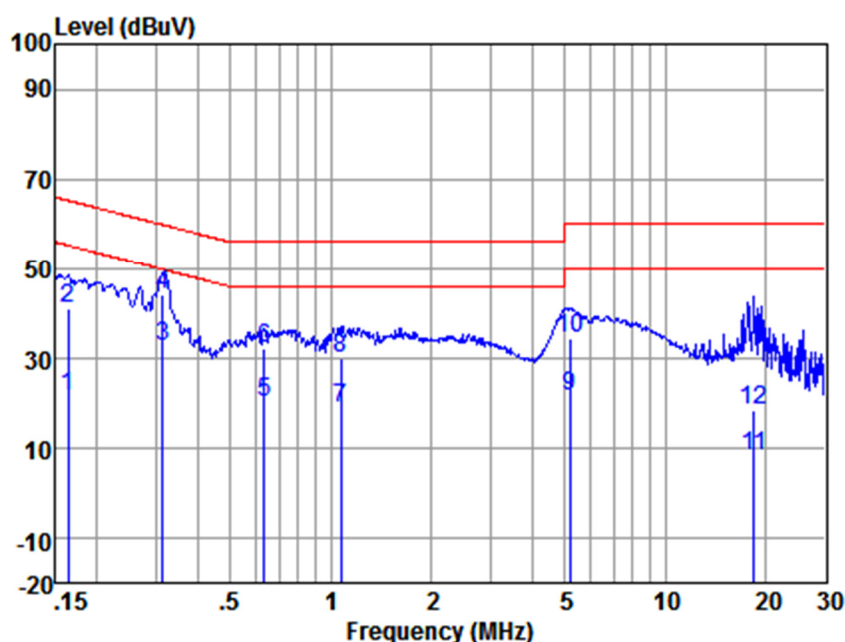


#### 6.1.3 Measurement Data

An initial pre-scan was performed with peak detector. Quasi-Peak or Average measurement were performed at the frequencies with maximized peak emission were detected.

Notes: Emission Level=Read Level + LISN Factor + Cable Los

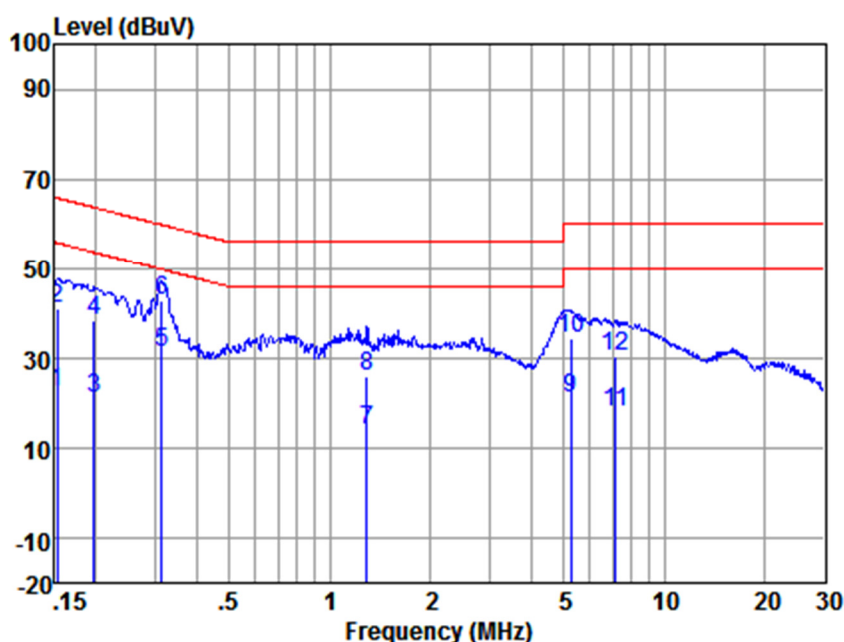
Mode:a; Line:Live Line



Site : chamber  
Condition : LISN-L-2017  
EUT/Project No: 0076IT  
Test mode : a

	Freq	Read	LISN	Cable	Limit	Over	
	MHz	Level	Factor	Loss	Line	Limit	Remark
	MHz	dBuV	dB	dB	dBuV	dB	
1	0.163	11.65	0.11	9.81	21.57	55.30	-33.73 Average
2	0.163	31.24	0.11	9.81	41.16	65.30	-24.14 QP
3	0.315	22.70	0.11	9.81	32.62	49.84	-17.22 Average
4	0.315	34.33	0.11	9.81	44.25	59.84	-15.59 QP
5	0.630	10.40	0.11	9.82	20.33	46.00	-25.67 Average
6	0.630	22.35	0.11	9.82	32.28	56.00	-23.72 QP
7	1.071	8.99	0.11	9.84	18.94	46.00	-27.06 Average
8	1.071	20.00	0.11	9.84	29.95	56.00	-26.05 QP
9	5.194	11.49	0.11	9.86	21.46	50.00	-28.54 Average
10	5.194	24.33	0.11	9.86	34.30	60.00	-25.70 QP
11	18.524	-1.69	0.17	10.03	8.51	50.00	-41.49 Average
12	18.524	8.42	0.17	10.03	18.62	60.00	-41.38 QP

Mode:a; Line:Neutral Line



Site : chamber  
Condition : LISN-N-2017  
EUT/Project No: 0076IT  
Test mode : a

	Freq	Read	LISN	Cable	Limit	Over	
	MHz	Level	Factor	Loss	Line	Limit	Remark
	MHz	dBuV	dB	dB	dBuV	dB	
1	0.152	12.51	0.12	9.81	22.44	55.87	-33.43 Average
2	0.152	31.21	0.12	9.81	41.14	65.87	-24.73 QP
3	0.198	11.30	0.12	9.81	21.23	53.71	-32.48 Average
4	0.198	28.68	0.12	9.81	38.61	63.71	-25.10 QP
5	0.315	21.32	0.11	9.81	31.24	49.84	-18.60 Average
6	0.315	33.11	0.11	9.81	43.03	59.84	-16.81 QP
7	1.289	4.16	0.11	9.84	14.11	46.00	-31.89 Average
8	1.289	15.92	0.11	9.84	25.87	56.00	-30.13 QP
9	5.277	11.23	0.13	9.86	21.22	50.00	-28.78 Average
10	5.277	24.28	0.13	9.86	34.27	60.00	-25.73 QP
11	7.175	8.31	0.13	9.86	18.30	50.00	-31.70 Average
12	7.175	20.47	0.13	9.86	30.46	60.00	-29.54 QP

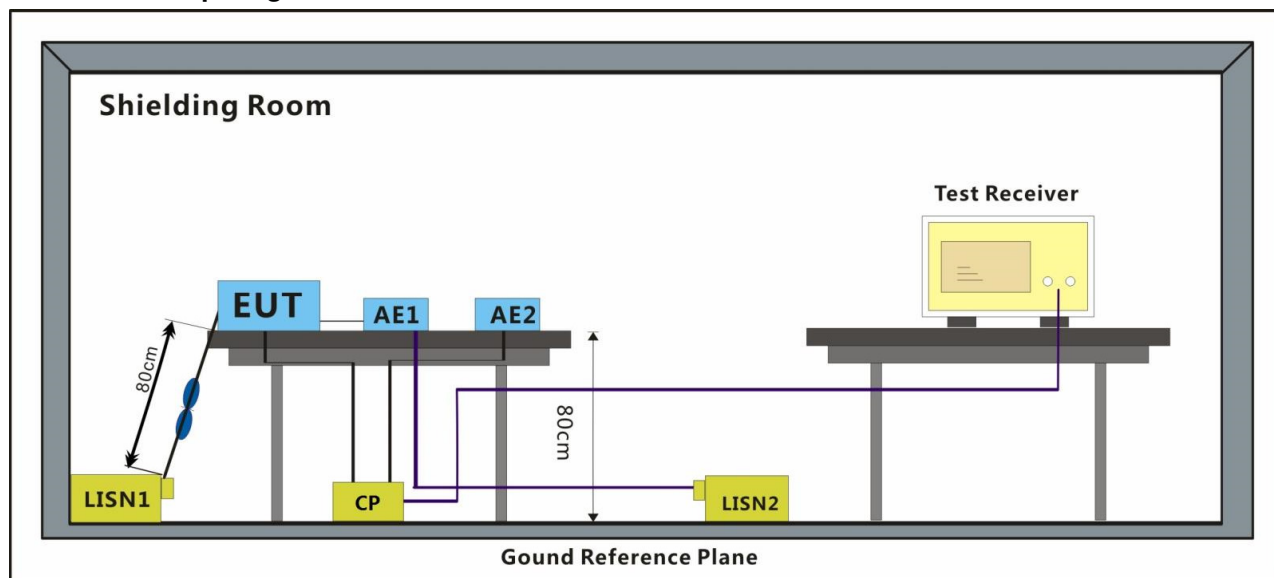
## 6.2 Asymmetric Mode Conducted Emissions (150kHz-30MHz)

Test Requirement:	EN 55032:2015
Test Method:	EN 55032:2015
Frequency Range:	150kHz to 30MHz
Limit:	
0.15M-0.5MHz(Voltage)	84-74(dBμV) quasi-peak; 74-64(dBμV) average
0.5M-30MHz(Voltage)	74(dBμV) quasi-peak; 64(dBμV) average
0.15M-0.5MHz(Current)	40-30(dBμA) quasi-peak; 30-20(dBμA) average
0.5M-30MHz(Current)	30(dBμA) quasi-peak; 20(dBμA) average
Detector:	9kHz resolution bandwidth 0.15M to 30MHz
Remark:	The voltage measured shall be corrected at each frequency of interest as follows: if the current margin with respect to the current limit is $\leq 6$ dB, the actual current margin shall be subtracted from the measured voltage; if the current margin with respect to the current limit is $> 6$ dB, 6 dB shall be subtracted from the measured voltage.

### 6.2.1 E.U.T. Operation

Operating Environment:					
Temperature:	22 °C	Humidity:	48 % RH	Atmospheric Pressure:	1010 mbar
Test mode	a:Normal Working connect EUT to laptop , keep EUT monitoring continual .				

### 6.2.2 Test Setup Diagram

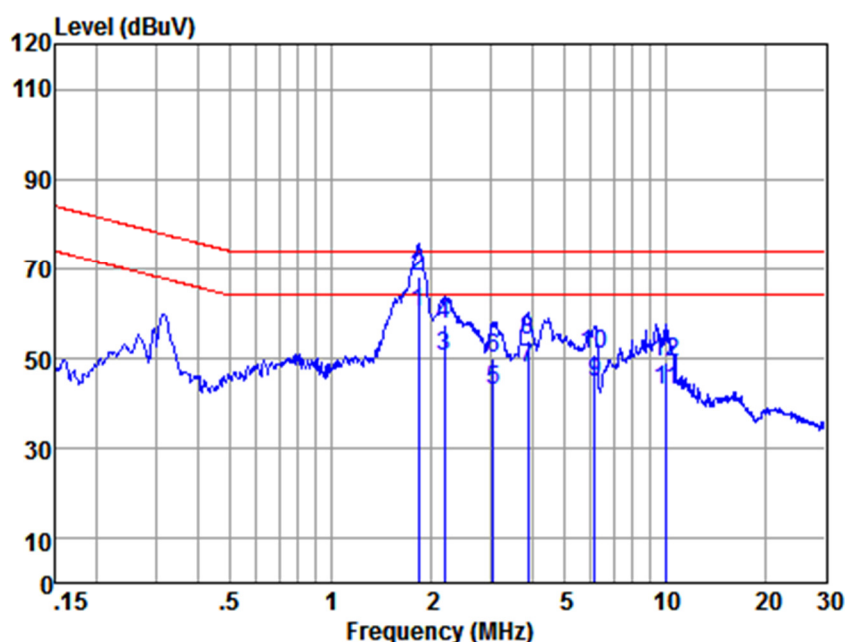


### 6.2.3 Measurement Data

Notes: Emission Level=Read Level + LISN Factor + Cable Los



Mode:a



Site : chamber  
Condition : ISN CAT5  
EUT/Project No: 0076IT  
Test mode : a

	Freq	Read Level	LISN Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB	dB	dBuV	dBuV	dB	
1	1.829	41.15	9.28	9.85	60.28	64.00	-3.72	Average
2	1.829	49.13	9.28	9.85	68.26	74.00	-5.74	QP
3	2.190	31.41	9.26	9.85	50.52	64.00	-13.48	Average
4	2.190	38.45	9.26	9.85	57.56	74.00	-16.44	QP
5	3.058	23.68	9.23	9.85	42.76	64.00	-21.24	Average
6	3.058	31.02	9.23	9.85	50.10	74.00	-23.90	QP
7	3.881	28.56	9.22	9.85	47.63	64.00	-16.37	Average
8	3.881	34.84	9.22	9.85	53.91	74.00	-20.09	QP
9	6.153	25.88	9.20	9.86	44.94	64.00	-19.06	Average
10	6.153	31.82	9.20	9.86	50.88	74.00	-23.12	QP
11	10.072	24.03	9.20	9.87	43.10	64.00	-20.90	Average
12	10.072	30.23	9.20	9.87	49.30	74.00	-24.70	QP

### 6.3 Radiated Emissions (30MHz-1GHz)

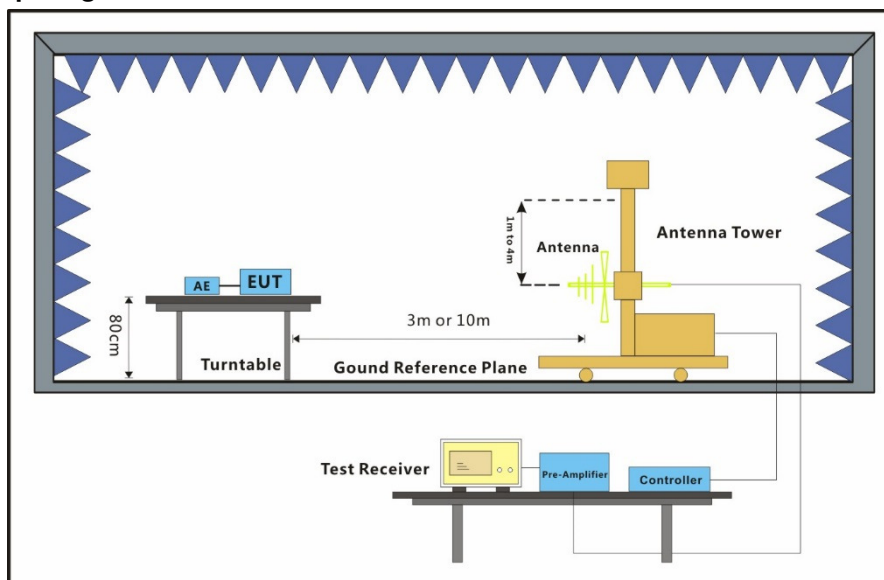
Test Requirement:	EN 55032:2015
Test Method:	EN 55032:2015
Frequency Range:	30MHz to 1GHz
Measurement Distance:	3m
Limit:	
30MHz-230MHz	40 dB( $\mu$ V/m) quasi-peak
230MHz-1GHz	47 dB( $\mu$ V/m) quasi-peak
Detector:	Peak for pre-scan (120kHz resolution bandwidth) 30M to 1000MHz

#### 6.3.1 E.U.T. Operation

Operating Environment:

Temperature:	22 °C	Humidity:	50 % RH	Atmospheric Pressure:	1005 mbar
Test mode	a:Normal Working_connect EUT to laptop , keep EUT monitoring continual .				

#### 6.3.2 Test Setup Diagram



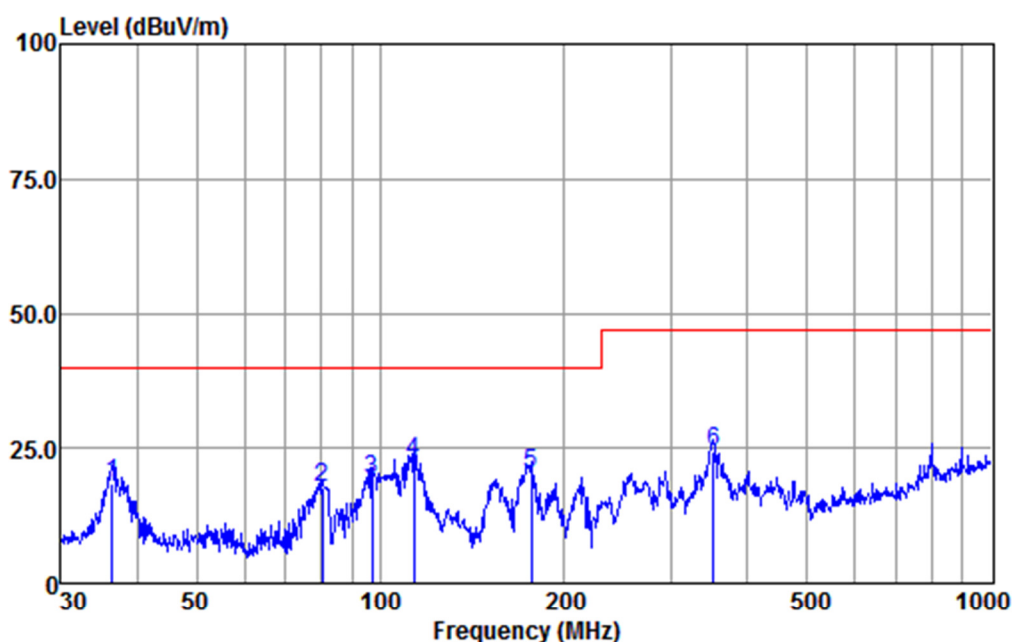
#### 6.3.3 Measurement Data

An initial pre-scan was performed in the chamber using the spectrum analyser in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by BiConiLog antenna with 2 orthogonal polarities.

Notes: Emission Level=Read Level + Antenna Factor + Cable Loss – Preamp Factor



Mode:a; Polarization:Horizontal



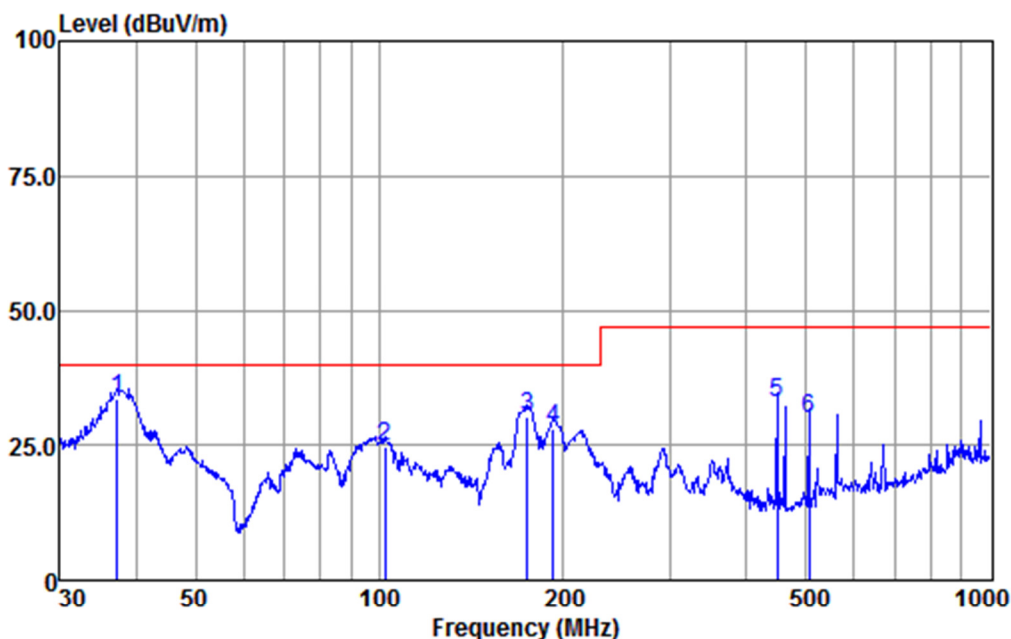
Condition : HORIZONTAL

EUT/Project: 0076IT

Test Mode : a

	Freq	ReadAntenna	Cable	Preamp		Limit	Over	
	MHz	Level	Factor	Loss	Factor	Level	Line	Limit
	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB
1	36.38	45.03	15.97	0.21	42.62	18.59	40.00	-21.41 QP
2	80.36	52.16	8.00	0.38	42.67	17.87	40.00	-22.13 QP
3	97.11	52.36	9.13	0.44	42.69	19.24	40.00	-20.76 QP
4 q	113.71	55.03	9.75	0.51	42.70	22.59	40.00	-17.41 QP
5	176.89	50.57	11.81	0.66	42.56	20.48	40.00	-19.52 QP
6	351.71	51.56	14.24	0.92	42.23	24.49	47.00	-22.51 QP

Mode:a; Polarization:Vertical



Condition : VERTICAL

EUT/Project: 0076IT

Test Mode : a

	Freq	ReadAntenna	Cable	Preamp		Limit	Over	
	MHz	Level	Factor	Loss	Factor	Level	Line	Limit
	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB
1 q	37.29	59.79	16.06	0.21	42.62	33.44	40.00	-6.56 QP
2	102.36	57.41	9.52	0.47	42.69	24.71	40.00	-15.29 QP
3	175.04	60.46	11.75	0.66	42.56	30.31	40.00	-9.69 QP
4	192.42	59.77	10.06	0.68	42.54	27.97	40.00	-12.03 QP
5	447.98	57.56	16.17	1.08	42.12	32.69	47.00	-14.31 QP
6	506.48	53.44	17.37	1.20	42.15	29.86	47.00	-17.14 QP

## 6.4 Radiated Emissions (above 1GHz)

Test Requirement: EN 55032:2015

Test Method: EN 55032:2015

Frequency Range: Above 1GHz

Measurement Distance: 3m

Limit:

1GHz-3GHz 70 dB(μV/m) peak, 50 dB(μV/m) average

3GHz-6GHz 74 dB(μV/m) peak, 54dB(μV/m) average

Detector: Peak for pre-scan (1000kHz resolution bandwidth) 1000M to 6000MHz

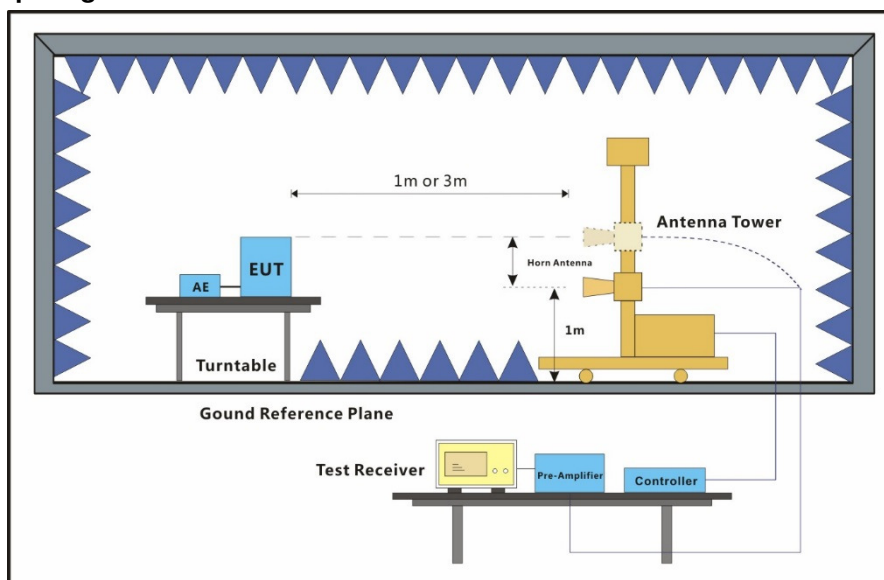
### 6.4.1 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1005 mbar

Test mode a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

### 6.4.2 Test Setup Diagram

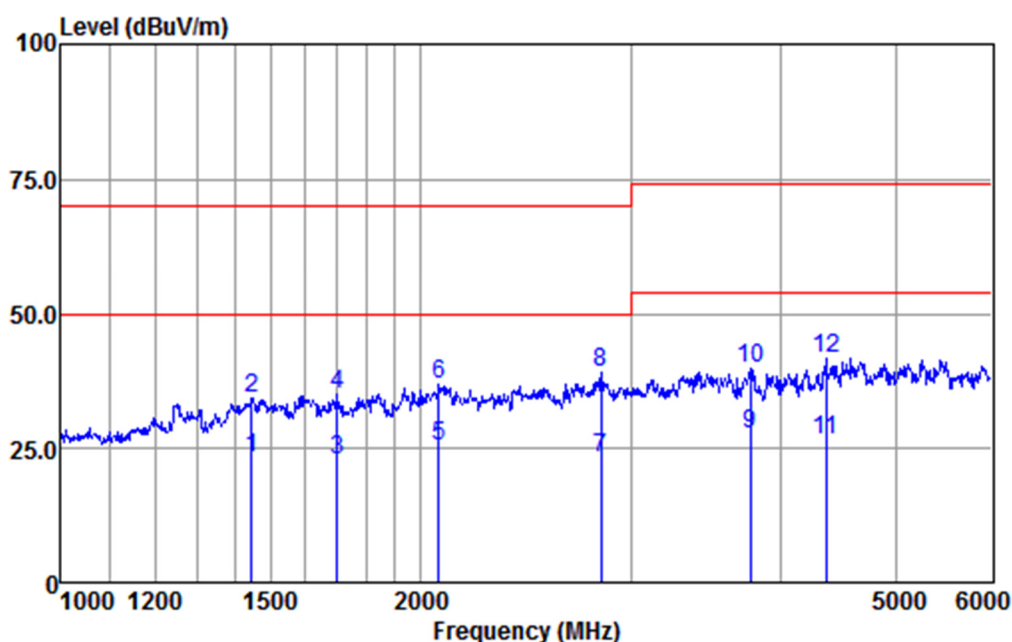


### 6.4.3 Measurement Data

An initial pre-scan was performed in the chamber using the spectrum analyser in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by BiConiLog antenna with 2 orthogonal polarities.

Notes: Emission Level=Read Level + Antenna Factor + Cable Loss – Preamp Factor

Mode:a; Polarization:Horizontal



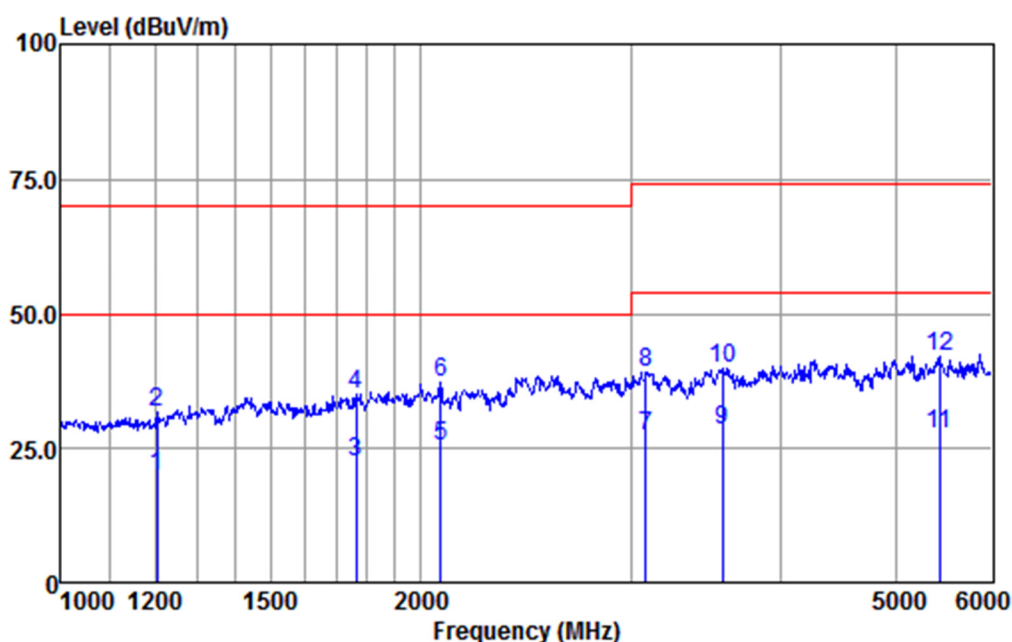
Condition : HORIZONTAL

EUT/Project: 0076IT

Test mode : a

	Freq	ReadAntenna	Cable	Preamp		Limit	Over	
	MHz	Level	Factor	Loss	Factor	Level	Line	Limit
	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB
1	1443.85	36.47	25.10	3.75	41.91	23.41	50.00	-26.59 Average
2	1443.85	47.34	25.10	3.75	41.91	34.28	70.00	-35.72 Peak
3	1702.59	35.33	25.55	4.08	42.06	22.90	50.00	-27.10 Average
4	1702.59	47.50	25.55	4.08	42.06	35.07	70.00	-34.93 Peak
5	2069.81	36.74	26.22	4.60	42.21	25.35	50.00	-24.65 Average
6	2069.81	48.16	26.22	4.60	42.21	36.77	70.00	-33.23 Peak
7	2832.08	31.27	28.15	5.69	41.86	23.25	50.00	-26.75 Average
8 p	2832.08	47.23	28.15	5.69	41.86	39.21	70.00	-30.79 Peak
9	3772.33	33.56	29.30	6.60	41.92	27.54	54.00	-26.46 Average
10	3772.33	45.93	29.30	6.60	41.92	39.91	74.00	-34.09 Peak
11	4369.37	30.48	30.38	7.55	41.74	26.67	54.00	-27.33 Average
12	4369.37	45.55	30.38	7.55	41.74	41.74	74.00	-32.26 Peak

Mode:a; Polarization:Vertical



Condition : VERTICAL

EUT/Project: 0076IT

Test mode : a

	Freq	ReadAntenna	Cable	Preamp		Limit	Over	
	MHz	Level	Factor	Loss	Factor	Level	Line	Limit
	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB
1	1202.68	33.67	24.60	3.40	41.83	19.84	50.00	-30.16 Average
2	1202.68	45.62	24.60	3.40	41.83	31.79	70.00	-38.21 Peak
3	1767.88	34.81	25.66	4.17	42.10	22.54	50.00	-27.46 Average
4	1767.88	47.47	25.66	4.17	42.10	35.20	70.00	-34.80 Peak
5	2080.96	36.83	26.25	4.60	42.21	25.47	50.00	-24.53 Average
6	2080.96	48.77	26.25	4.60	42.21	37.41	70.00	-32.59 Peak
7	3086.44	34.59	28.56	5.85	41.74	27.26	54.00	-26.74 Average
8	3086.44	46.48	28.56	5.85	41.74	39.15	74.00	-34.85 Peak
9	3574.91	34.87	28.95	6.39	41.88	28.33	54.00	-25.67 Average
10	3574.91	46.36	28.95	6.39	41.88	39.82	74.00	-34.18 Peak
11	5436.92	29.54	31.86	8.28	41.96	27.72	54.00	-26.28 Average
12 p	5436.92	43.84	31.86	8.28	41.96	42.02	74.00	-31.98 Peak

## 6.5 Harmonic Current Emission

Test Requirement: EN 61000-3-2:2014

Test Method: EN 61000-3-2:2014

Frequency Range: 100Hz to 2kHz

There is no need for Harmonics test to be performed on this product (rated power is less than 75W) in accordance with EN 61000-3-2:2014.

For further details, please refer to Clause 7 of EN 61000-3-2 which states:

"For the following categories of equipment, limits are not specified in this standard.- equipment with a rated power of 75W or less, other than lighting equipment."



## 6.6 Voltage Fluctuations and Flicker

Test Requirement: EN 61000-3-3:2013

Test Method: EN 61000-3-3:2013

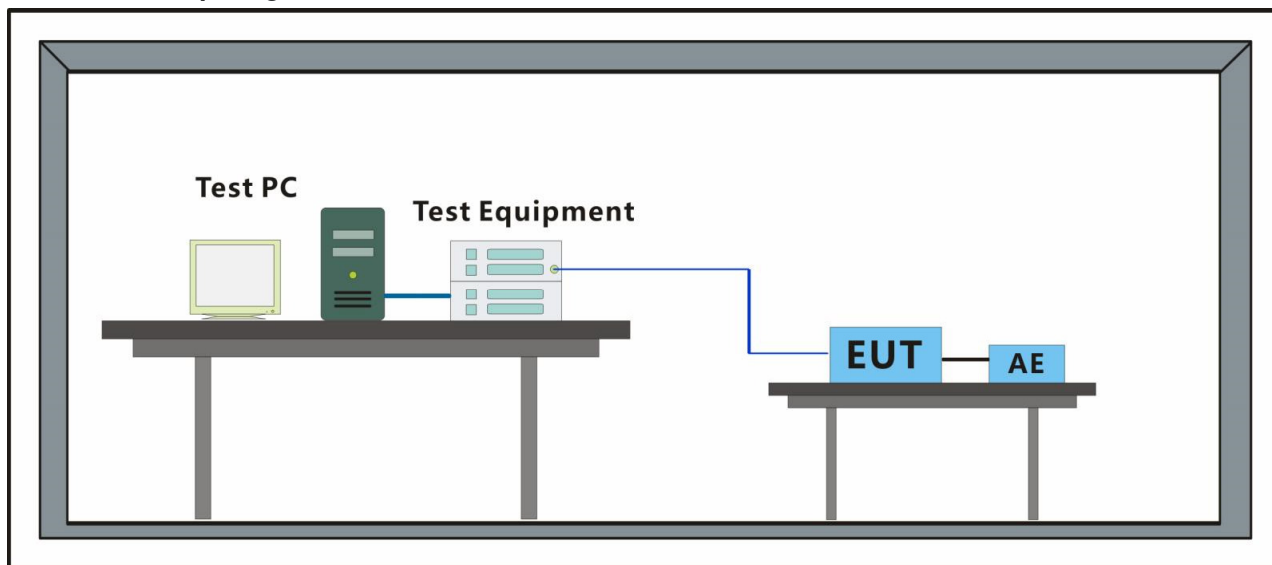
### 6.6.1 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 51 % RH Atmospheric Pressure: 1020 mbar

Test mode a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

### 6.6.2 Test Setup Diagram



### 6.6.3 Measurement Data

Mode:a

Parameter values recorded during the test:

Vrms at the end of test (Volt): 229.86

T-max (mS): 0

Highest dc (%): 0.23

Highest dmax (%): 0.28

Highest Pst (10 min. period): 0.137

Highest Plt (2 hr. period): 0.082

Test limit (mS): 500.0 Pass

Test limit (%): 3.30 Pass

Test limit (%): 4.00 Pass

Test limit: 1.000 Pass

Test limit: 0.650 Pass

## 7 Immunity Test Results

### 7.1 Performance Criteria Description in EN 55024:2010 +A1:2015

#### Criterion A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

#### Criterion B

After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.

If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

#### Criterion C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.

Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

### 7.2 Performance Criteria Description in EN 50130-4:2011 +A1:2014

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

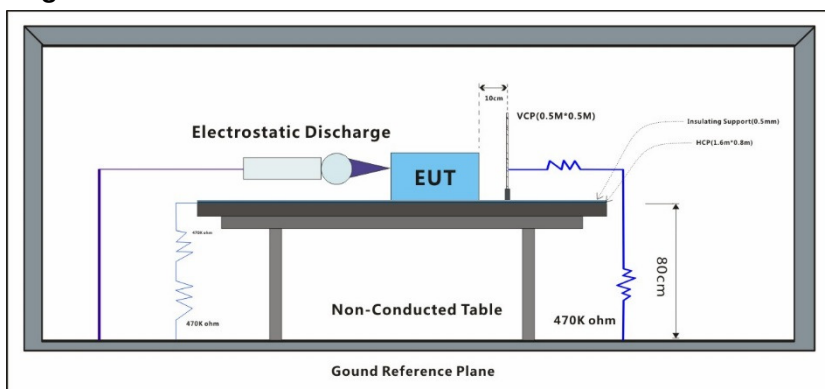
For further details, please refer to Clause 7.4, 8.4, 9.4, 10.4, 11.4, 12.4 and 13.4, of EN 50130-4.



### 7.3 Electrostatic Discharge

Test Requirement: EN 55024:2010 +A1:2015  
 Test Method: EN 61000-4-2:2009  
 Performance Criterion: B  
 Discharge Impedance: 330Ω/150pF  
 Number of Discharge: Minimum of four test points (a minimum of 50 discharges at each point)  
 Discharge Mode: Single Discharge  
 Discharge Period: 1 second minimum

#### 7.3.1 Test Setup Diagram



#### 7.3.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

#### 7.3.3 Test Results:

Observations: Test Point:

1. All insulated enclosure and seams.
2. All accessible metal parts of the enclosure.
3. All side

Discharge type	Level (kV)	Polarity	Test Point	Result / Observations
Air Discharge	2,4,8	+	1	A
Air Discharge	2,4,8	-	1	A
Contact Discharge	4	+	2	A
Contact Discharge	4	-	2	A
Horizontal Coupling	4	+	3	A
Horizontal Coupling	4	-	3	A
Vertical Coupling	4	+	3	A
Vertical Coupling	4	-	3	A

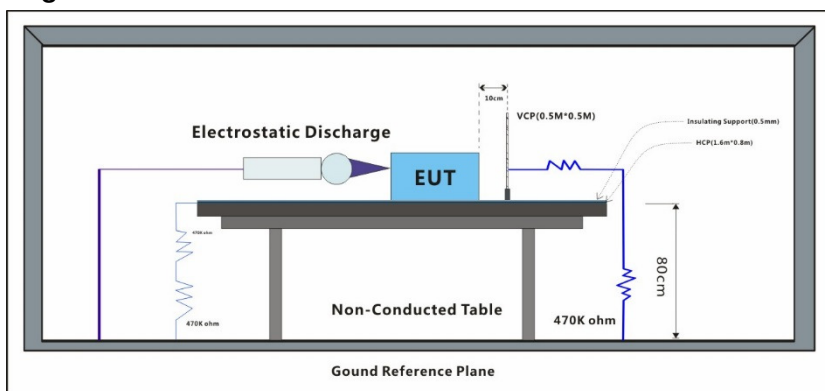
#### Results:

A: No degradation in the performance of the EUT was observed.

## 7.4 Electrostatic Discharge

Test Requirement: EN 50130-4:2011 +A1:2014  
 Test Method: EN 61000-4-2:2009  
 Number of Discharge: Minimum 10 times at each test point for Air Discharge  
 Minimum 50 times at each test point for Contact or VCP & HCP Discharge  
 Discharge Mode: Single Discharge  
 Discharge Period: 1 second minimum  
 Criteria for compliance: There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residu

### 7.4.1 Test Setup Diagram



### 7.4.2 E.U.T. Operation

Operating Environment:  
 Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar  
 Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

### 7.4.3 Test Results:

Observations: Test Point:  
 1. All insulated enclosure and seams.  
 2. All accessible metal parts of the enclosure.  
 3. All side

Discharge type	Level (kV)	Polarity	Test Point	Result / Observations
Air Discharge	2,4,8	+	1	A
Air Discharge	2,4,8	-	1	A
Contact Discharge	6	+	2	A
Contact Discharge	6	-	2	A
Horizontal Coupling	6	+	3	A
Horizontal Coupling	6	-	3	A
Vertical Coupling	6	+	3	A
Vertical Coupling	6	-	3	A

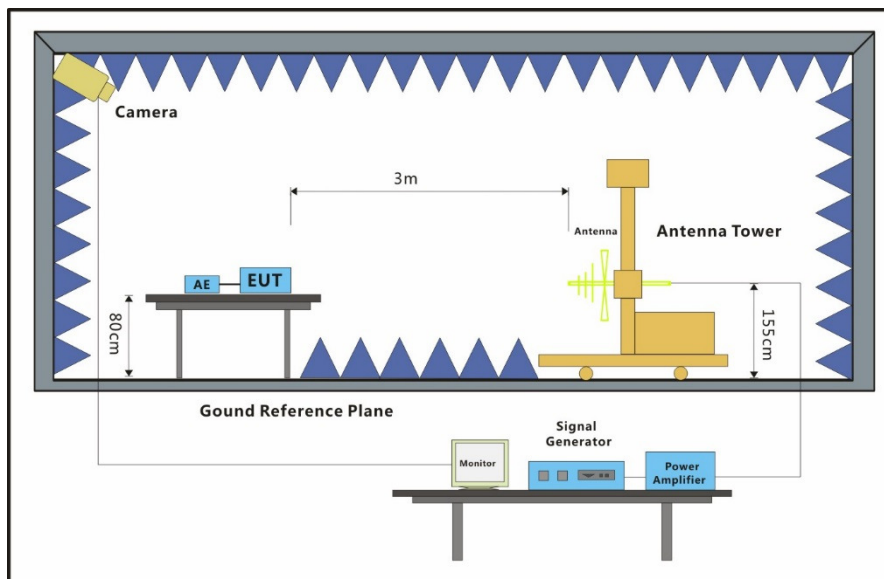
### Results:

A: No degradation in the performance of the EUT was observed.

## 7.5 Radiated Immunity (80MHz-1GHz)

Test Requirement: EN 55024:2010 +A1:2015  
 Test Method: EN 61000-4-3:2006 +A1:2008+A2:2010  
 Performance Criterion: A  
 Frequency Range: 80MHz to 1GHz  
 Antenna Polarisation: Vertical and Horizontal  
 Modulation: 1kHz,80% Amp. Mod,1% increment

### 7.5.1 Test Setup Diagram



### 7.5.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1005 mbar

Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

### 7.5.3 Test Results:

Frequency	Level (V/m)	EUT Face	Dwell time	Result / Observations
80MHz-1GHz	3	Front	3s	A
80MHz-1GHz	3	Back	3s	A
80MHz-1GHz	3	Left	3s	A
80MHz-1GHz	3	Right	3s	A
80MHz-1GHz	3	Top	3s	A
80MHz-1GHz	3	Underside	3s	A

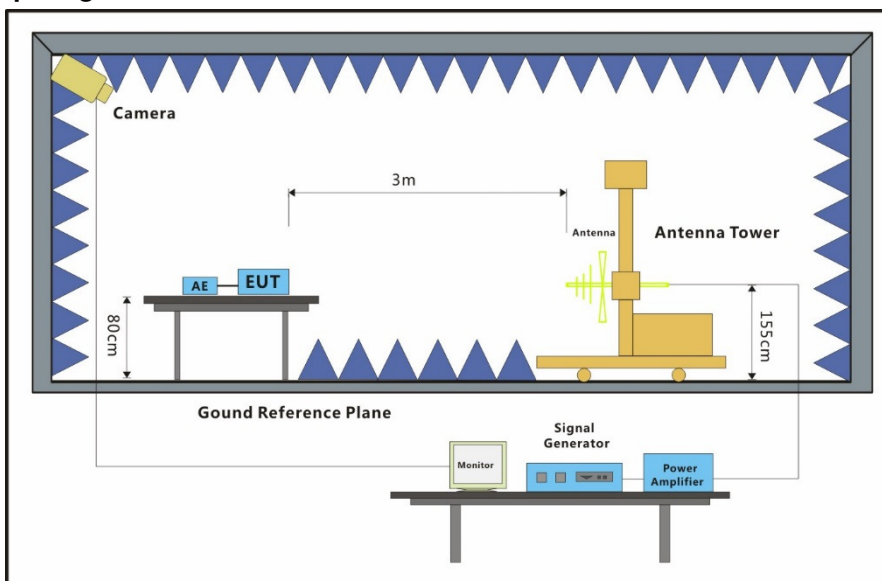
### Results:

A: No degradation in the performance of the EUT was observed.

## 7.6 Radiated Immunity(80MHz-2.7GHz)

Test Requirement: EN 50130-4:2011 +A1:2014  
 Test Method: EN 61000-4-3:2006 +A1:2008+A2:2010  
 Modulation: 80%, 1 kHz Amplitude Modulation & 0.5s ON 0.5s OFF Pulse Modulation  
 Criteria for compliance: There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the

### 7.6.1 Test Setup Diagram



### 7.6.2 E.U.T. Operation

Operating Environment:  
 Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1005 mbar  
 Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

### 7.6.3 Test Results:

Frequency	Level (V/m)	EUT Face	Dwell time	Result / Observations
80MHz-2.7GHz	10	Front	3s	A
80MHz-2.7GHz	10	Back	3s	A
80MHz-2.7GHz	10	Left	3s	A
80MHz-2.7GHz	10	Right	3s	A
80MHz-2.7GHz	10	Top	3s	A
80MHz-2.7GHz	10	Underside	3s	A

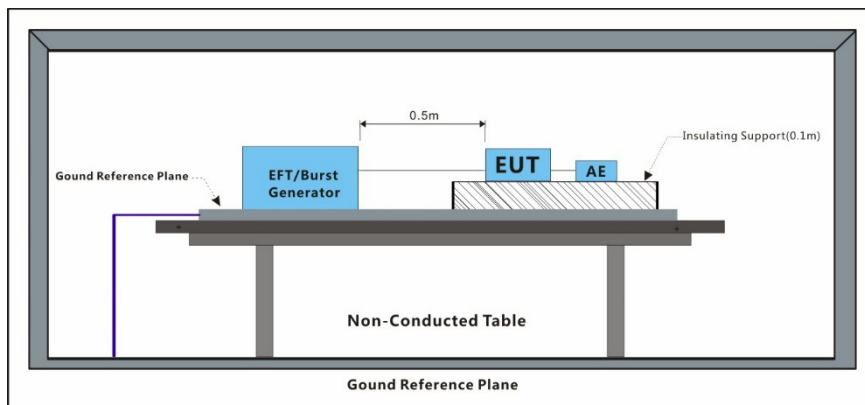
### Results:

A: No degradation in the performance of the EUT was observed.

## 7.7 Electrical Fast Transients/Burst at Power Port

Test Requirement: EN 55024:2010 +A1:2015  
 Test Method: EN 61000-4-4:2012  
 Performance Criterion: B  
 Repetition Frequency: 5kHz  
 Burst Period: 300ms  
 Test Duration: 2 minute per level & polarity

### 7.7.1 Test Setup Diagram



### 7.7.2 E.U.T. Operation

Operating Environment:  
 Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar  
 Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

### 7.7.3 Test Results:

Test Line	Level (kV)	Polarity	CDN/Clamp	Result / Observations
AC power port	1	+	CDN	A
AC power port	1	-	CDN	A

#### Results:

A: No degradation in the performance of the EUT was observed.

## 7.8 Electrical Fast Transients/Burst at Power Port

Test Requirement: EN 50130-4:2011 +A1:2014

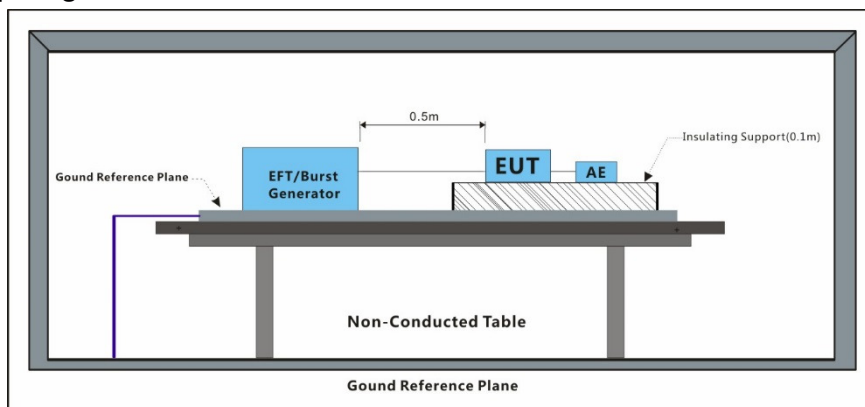
Test Method: EN 61000-4-4:2012

Repetition Frequency: 100kHz

Burst Period: 300ms

Test Duration: 1 minute per level & polarity

### 7.8.1 Test Setup Diagram



### 7.8.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

### 7.8.3 Test Results:

Test Line	Level (kV)	Polarity	CDN/Clamp	Result / Observations
AC power port	2	+	CDN	A
AC power port	2	-	CDN	A

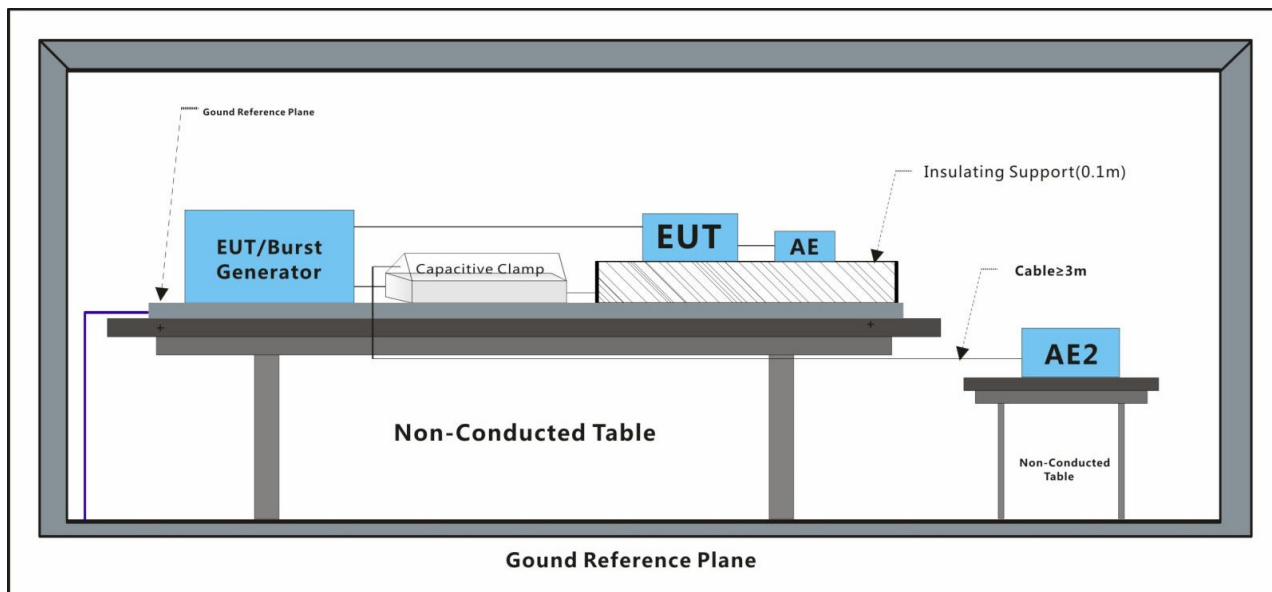
#### Results:

A: No degradation in the performance of the EUT was observed.

## 7.9 Electrical Fast Transients/Burst at Signal Port

Test Requirement: EN 55024:2010 +A1:2015  
 Test Method: EN 61000-4-4:2012  
 Performance Criterion: B  
 Repetition Frequency: 5kHz  
 Burst Period: 300ms  
 Test Duration: 2 minute per level & polarity

### 7.9.1 Test Setup Diagram



### 7.9.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

### 7.9.3 Test Results:

Port	Level (kV)	Polarity	CDN/Clamp	Result / Observations
Signal port	0.5	+	Clamp	A
Signal port	0.5	-	Clamp	A

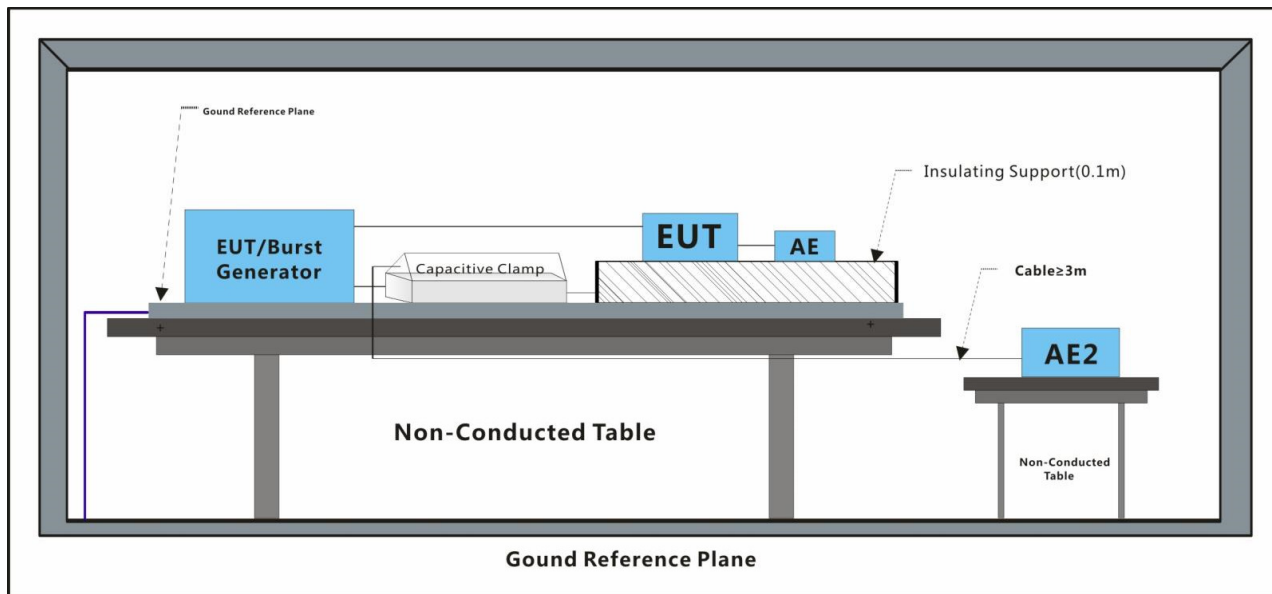
#### Results:

A: No degradation in the performance of the EUT was observed.

### 7.10 Electrical Fast Transients/Burst at Signal Port

Test Requirement: EN 50130-4:2011 +A1:2014  
 Test Method: EN 61000-4-4:2012  
 Repetition Frequency: 100kHz  
 Burst Period: 300ms  
 Test Duration: 1 minute per level & polarity

#### 7.10.1 Test Setup Diagram



#### 7.10.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar

Test mode: a: Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

#### 7.10.3 Test Results:

Port	Level (kV)	Polarity	CDN/Clamp	Result / Observations
Signal port	1	+	Clamp	A
Signal port	1	-	Clamp	A

#### Results:

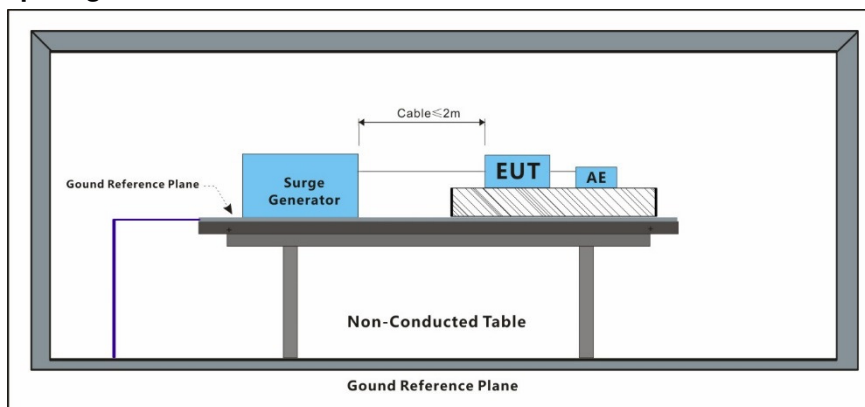
A: No degradation in the performance of the EUT was observed.



## 7.11 Surge at Power Port

Test Requirement: EN 55024:2010 +A1:2015  
 Test Method: EN 61000-4-5:2014  
 Performance Criterion: B  
 Interval: 60s between each surge  
 No. of surges: 5 positive, 5 negative at 0°, 90°, 180°, 270°.

### 7.11.1 Test Setup Diagram



### 7.11.2 E.U.T. Operation

Operating Environment:  
 Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar  
 Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

### 7.11.3 Test Results:

Test Line	Level (kV)	Polarity	Phase (deg)	Result / Observations
L-N	1	+	0°	A
L-N	1	-	0°	A
L-N	1	+	90°	A
L-N	1	-	90°	A
L-N	1	+	180°	A
L-N	1	-	180°	A
L-N	1	+	270°	A
L-N	1	-	270°	A

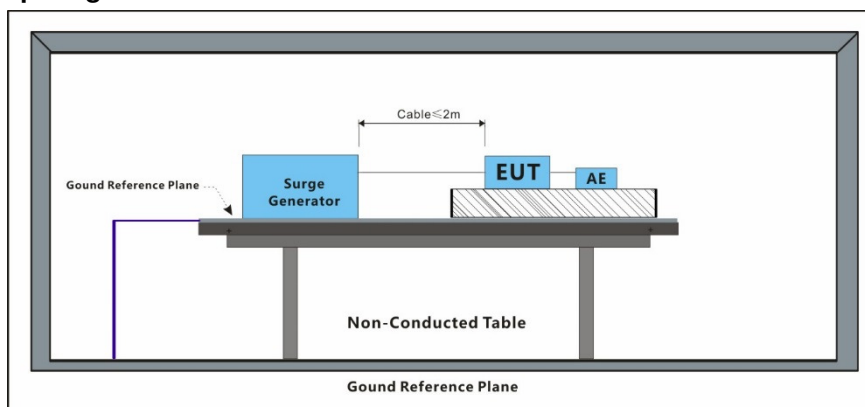
#### Results:

A: No degradation in the performance of the EUT was observed.

## 7.12 Surge at Power Port

Test Requirement:	EN 50130-4:2011 +A1:2014
Test Method:	EN 61000-4-5:2014
Interval:	60s between each surge
No. of surges:	5 positive, 5 negative
Criteria for compliance:	There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residu

### 7.12.1 Test Setup Diagram



### 7.12.2 E.U.T. Operation

Operating Environment:					
Temperature:	22 °C	Humidity:	50 % RH	Atmospheric Pressure:	1002 mbar
Test mode:	a:Normal Working connect EUT to laptop , keep EUT monitoring continual .				

### 7.12.3 Test Results:

Test Line	Level (kV)	Polarity	Phase (deg)	Result / Observations
L-N	0.5,1	+	0°	A
L-N	0.5,1	-	0°	A
L-N	0.5,1	+	90°	A
L-N	0.5,1	-	90°	A
L-N	0.5,1	+	180°	A
L-N	0.5,1	-	180°	A
L-N	0.5,1	+	270°	A
L-N	0.5,1	-	270°	A

#### Results:

A: No degradation in the performance of the EUT was observed.

### 7.13 Surge at Signal Port

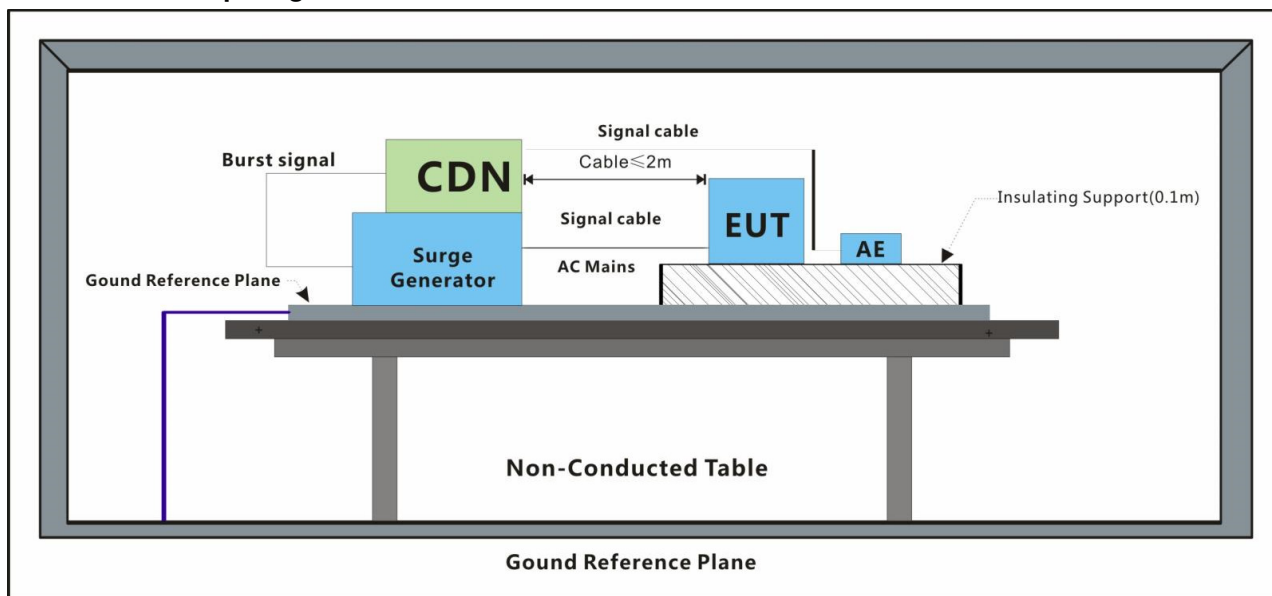
Test Requirement: EN 55024:2010 +A1:2015

Test Method: EN 61000-4-5:2014

Performance Criterion: B

Interval: 60s between each surge

#### 7.13.1 Test Setup Diagram



#### 7.13.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

#### 7.13.3 Test Results:

Port	Line	Level (kV)	Polarity	Result / Observations
Signal port	Line-Ground	1	+	A
Signal port	Line-Ground	1	-	A

#### Results:

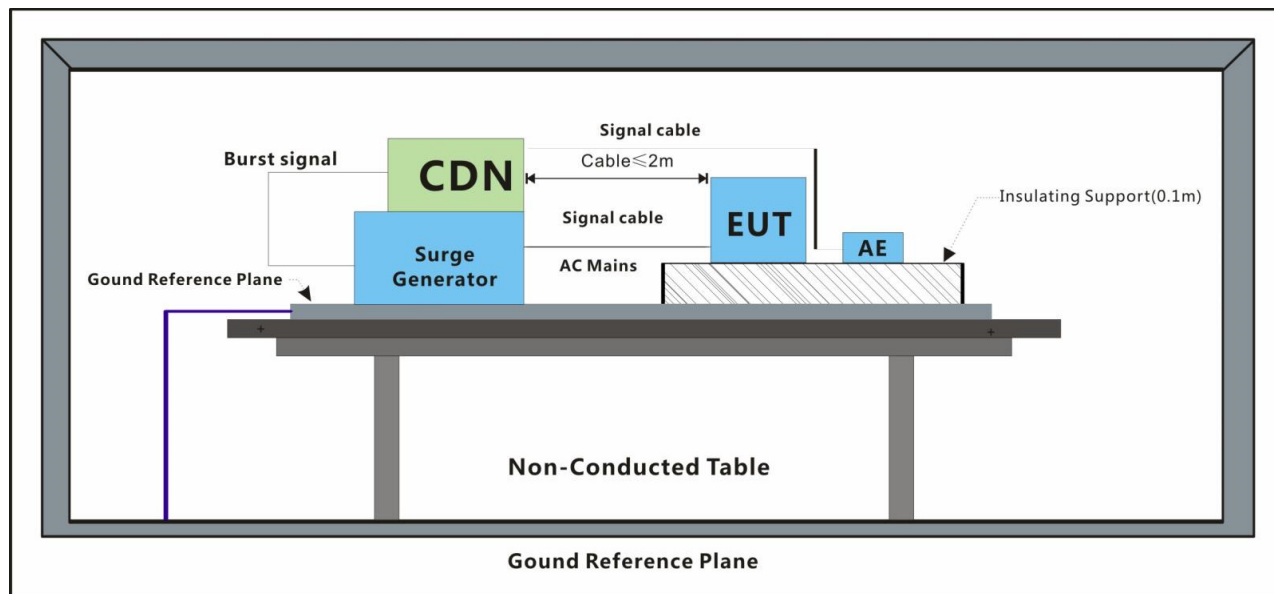
A: No degradation in the performance of the EUT was observed.

## 7.14 Surge at Signal Port

Test Requirement: EN 50130-4:2011 +A1:2014

Test Method: EN 61000-4-5:2014

### 7.14.1 Test Setup Diagram



### 7.14.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

### 7.14.3 Test Results:

Port	Line	Level (kV)	Polarity	Result / Observations
Signal port	Line-Ground	0.5	+	A
Signal port	Line-Ground	0.5	-	A
Signal port	Line-Ground	1	+	A
Signal port	Line-Ground	1	-	A

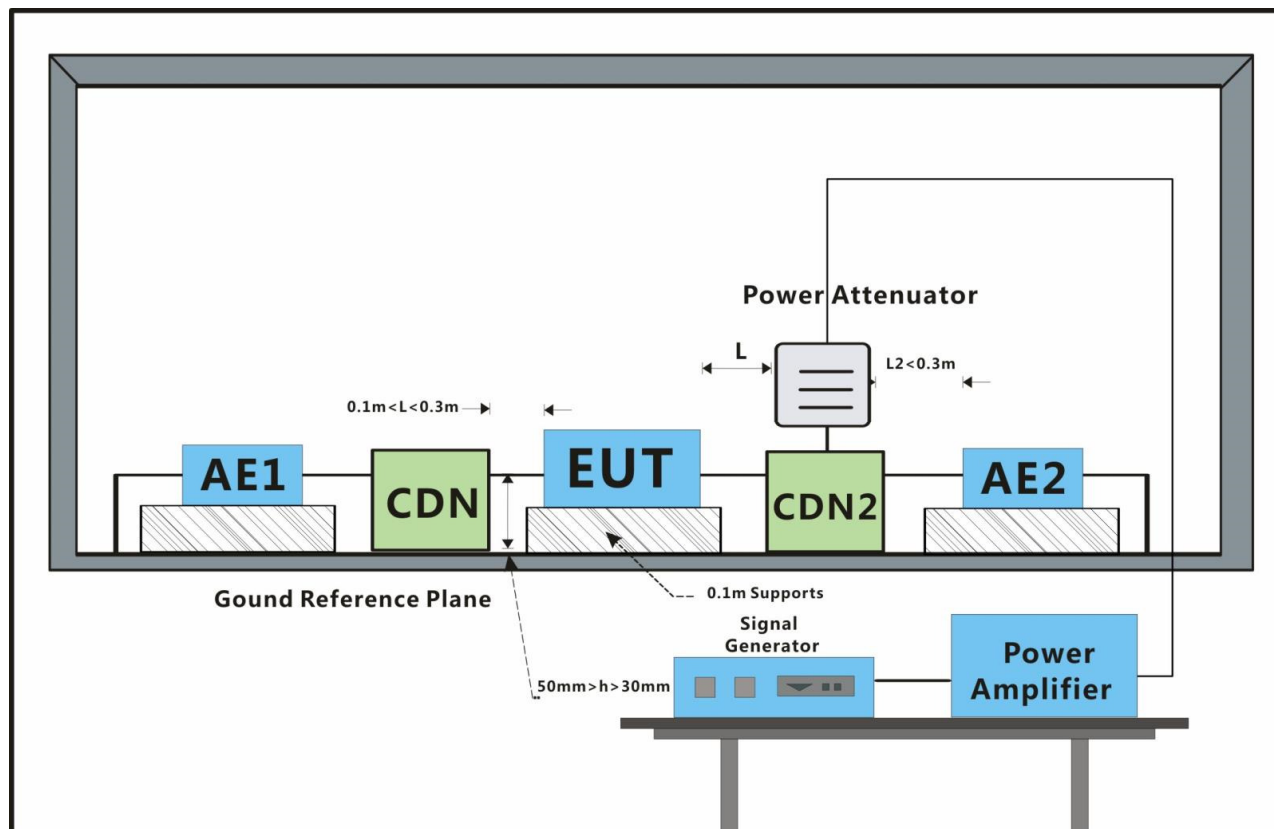
#### Results:

A: No degradation in the performance of the EUT was observed.

### 7.15 Conducted Immunity at Power Port (150kHz-80MHz)

Test Requirement:	EN 55024:2010 +A1:2015
Test Method:	EN 61000-4-6:2014
Performance Criterion:	A
Frequency Range:	0.15MHz to 80MHz
Modulation:	80%, 1kHz Amplitude Modulation
Step Size	1%

### 7.15.1 Test Setup Diagram



### 7.15.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C      Humidity: 50 % RH      Atmospheric Pressure: 1020 mbar

Test mode:           a:Normal Working connect EUT to laptop , keep EUT monitoring continual .

### 7.15.3 Test Results:

Cable port	Level (Vrms)	CDN/Clamp	Dwell time	Result / Observations
AC power port	3	CDN	3s	A

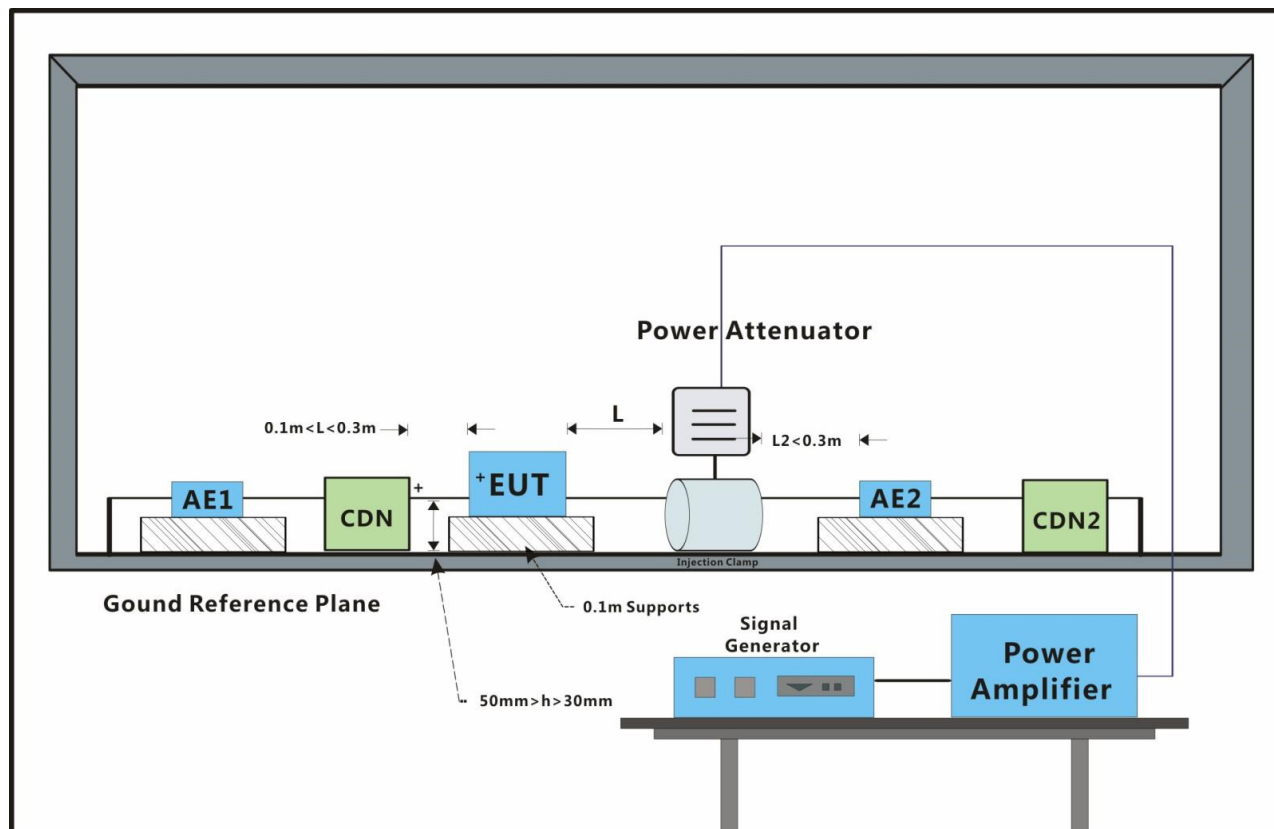
**Results:**

A: No degradation in the performance of the EUT was observed.

## 7.16 Conducted Immunity at Signal Port (150kHz-80MHz)

Test Requirement: EN 55024:2010 +A1:2015  
 Test Method: EN 61000-4-6:2014  
 Performance Criterion: A  
 Frequency Range: 0.15MHz to 80MHz  
 Modulation: 80%, 1kHz Amplitude Modulation  
 Step Size: 1%

### 7.16.1 Test Setup Diagram



### 7.16.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1020 mbar

Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

### 7.16.3 Test Results:

Port	Level (Vrms)	CDN/Clamp	Dwell time	Result / Observations
Signal port	3	Coupling	3s	A

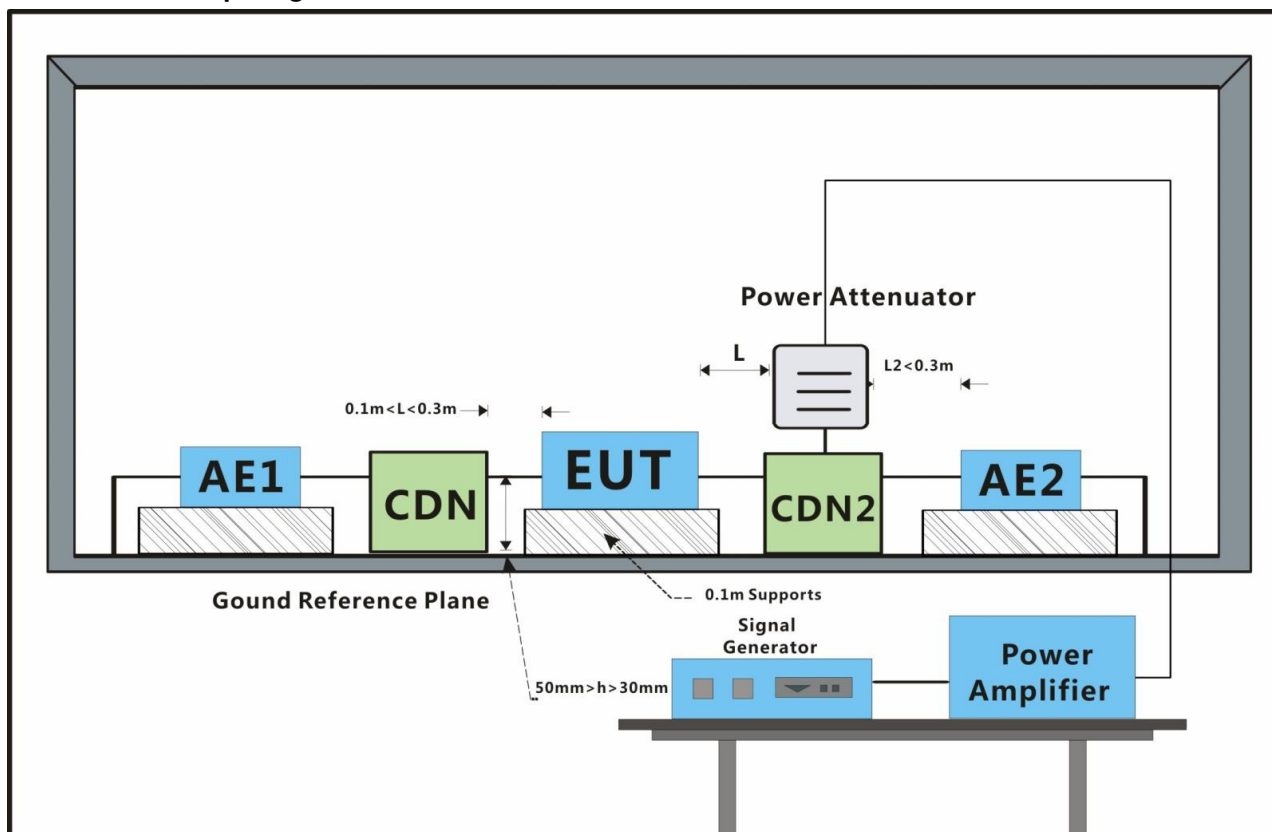
#### Results:

A: No degradation in the performance of the EUT was observed.

### 7.17 Conducted Immunity at Power Port (150kHz-100MHz)

Test Requirement: EN 50130-4:2011 +A1:2014  
 Test Method: EN 61000-4-6:2014  
 Modulation: 80%, 1 kHz Amplitude Modulation & 0.5s ON 0.5s OFF Pulse Modulation  
 Criteria for compliance: There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the

#### 7.17.1 Test Setup Diagram



#### 7.17.2 E.U.T. Operation

Operating Environment:  
 Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1020 mbar  
 Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

#### 7.17.3 Test Results:

Cable port	Level (Vrms)	CDN/Clamp	Dwell time	Result / Observations
AC power port	10	CDN	3s	A

#### Results:

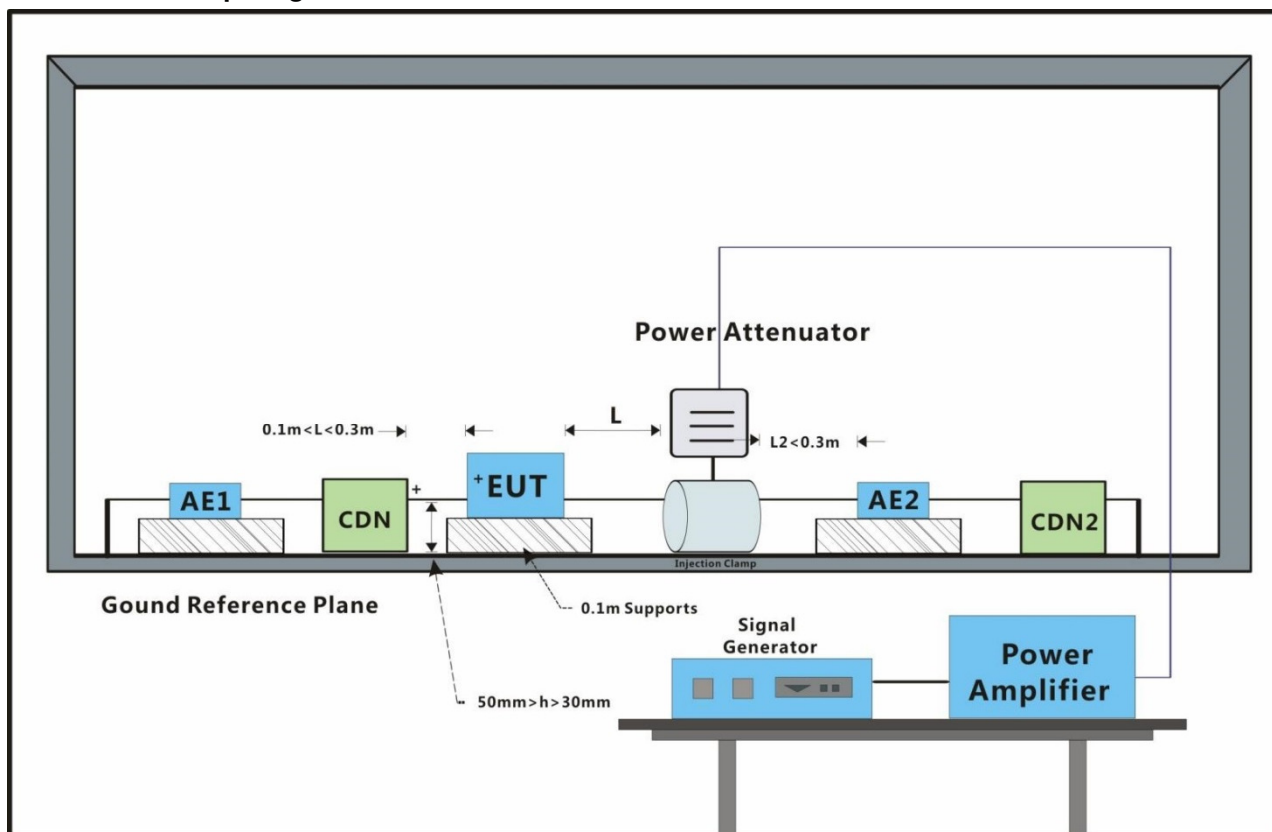
A: No degradation in the performance of the EUT was observed.



## 7.18 Conducted Immunity at Signal Port (150kHz-100MHz)

Test Requirement: EN 50130-4:2011 +A1:2014  
 Test Method: EN 61000-4-6:2014  
 Modulation: 80%, 1 kHz Amplitude Modulation & 0.5s ON 0.5s OFF Pulse Modulation  
 Criteria for compliance: There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the

### 7.18.1 Test Setup Diagram



### 7.18.2 E.U.T. Operation

Operating Environment:  
 Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1020 mbar  
 Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

### 7.18.3 Test Results:

Port	Level (Vrms)	CDN/Clamp	Dwell time	Result / Observations
Signal port	10	Coupling	3s	A

#### Results:

A: No degradation in the performance of the EUT was observed.

## 7.19 Voltage Dips and Interruptions

Test Requirement: EN 55024:2010 +A1:2015

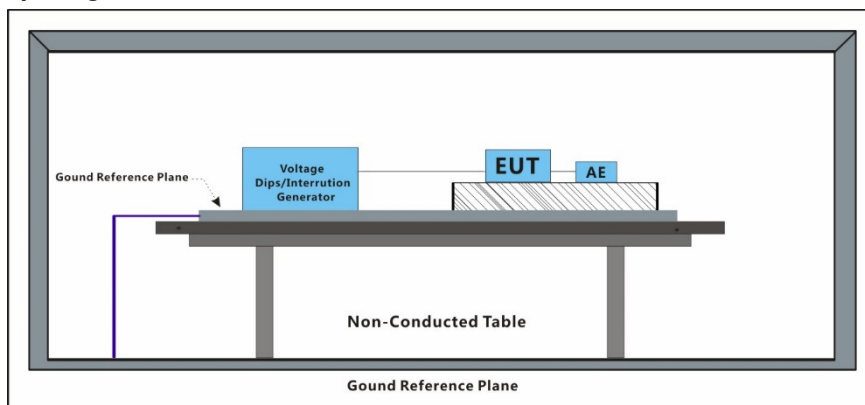
Test Method: EN 61000-4-11:2004

Performance Criterion: 0% of UT (Supply Voltage) for 0.5 Periods:B; 0% of UT for 250 Periods:C; 70 % of UT for 25 Periods:C

No. of Dips / Interruptions: 3 per Level

Time between dropout 10s

### 7.19.1 Test Setup Diagram



### 7.19.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar

Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

### 7.19.3 Test Results:

Level % UT	Phase (deg)	Duration	No. of Dips / Interruptions	Result / Observations
0	0°	0.5 Cycles	3	A
0	180°	0.5 Cycles	3	A
0	0°	250 Cycles	3	C
0	180°	250 Cycles	3	C
70	0°	25 Cycles	3	A
70	180°	25 Cycles	3	A

#### Results:

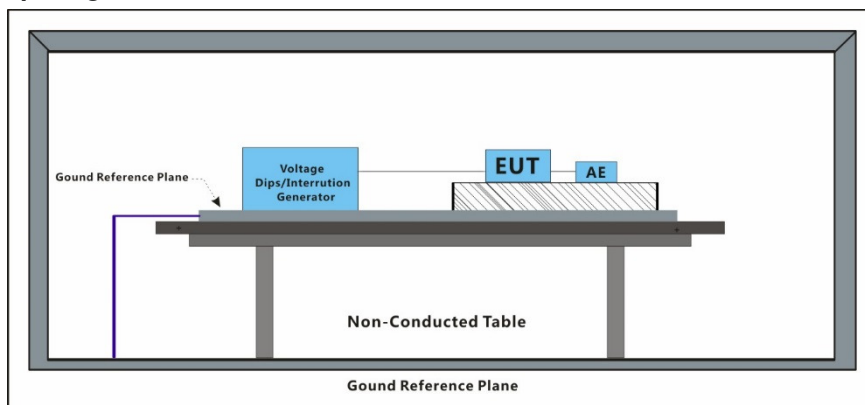
A: No degradation in the performance of the EUT was observed.

C: During test, EUT stop work, After test ,EUT restart by operator

## 7.20 Voltage Dips and Interruptions

Test Requirement: EN 50130-4:2011 +A1:2014  
 Test Method: EN 61000-4-11:2004  
 Performance Criterion: 0% of UT (Supply Voltage) for 250 Periods; 40% of UT for 10 Periods;  
 70% of UT for 25 Periods; 80% of UT for 250 Periods;  
 No. of Dips / Interruptions: 3 per Level  
 Time between dropout 10s

### 7.20.1 Test Setup Diagram



### 7.20.2 E.U.T. Operation

Operating Environment:  
 Temperature: 22 °C Humidity: 50 % RH Atmospheric Pressure: 1002 mbar  
 Test mode: a:Normal Working\_connect EUT to laptop , keep EUT monitoring continual .

### 7.20.3 Test Results:

Level % UT	Phase (deg)	Duration	No. of Dips / Interruptions	Result / Observations
80	0°	250 Cycles	3	A
80	180°	250 Cycles	3	A
70	0°	25 Cycles	3	A
70	180°	25 Cycles	3	A
40	0°	10 Cycles	3	A
40	180°	10 Cycles	3	A
0	0°	250 Cycles	3	C
0	180°	250 Cycles	3	C

#### Results:

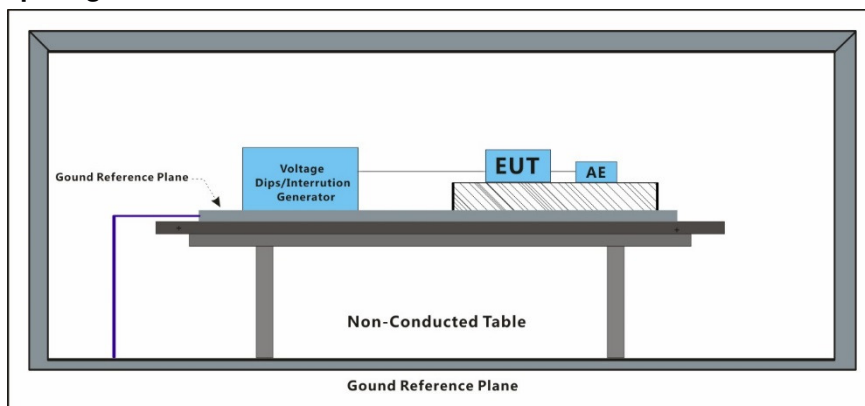
A: No degradation in the performance of the EUT was observed.

C: During test, EUT stop work, After test ,EUT restart by operator

## 7.21 Mains Supply Voltage Variations-Conditioning

Test Requirement:	EN 50130-4:2011 +A1:2014
Test Method:	EN 50130-4:2011+A1:2014
Voltage max.:	AC 253V ( $U_{max}$ : $U_{nom} + 10\%$ )
Voltage min.:	AC 195.55V ( $U_{min}$ : $U_{nom} - 15\%$ )
$U_{nom}$ Voltage:	AC 230V
Criteria:	There shall be no damage, malfunction or change of status due to the different supply voltage conditions. The EUT shall meet the acceptance criteria for the functional test (see Clause 6 of EN 50130-4

### 7.21.1 Test Setup Diagram



### 7.21.2 E.U.T. Operation

Operating Environment:					
Temperature:	22 °C	Humidity:	50 % RH	Atmospheric Pressure:	1002 mbar
Test mode:	a:Normal Working_connect EUT to laptop , keep EUT monitoring continual .				

### 7.21.3 Test Results:

#### Test phenomenon description for the EUT:

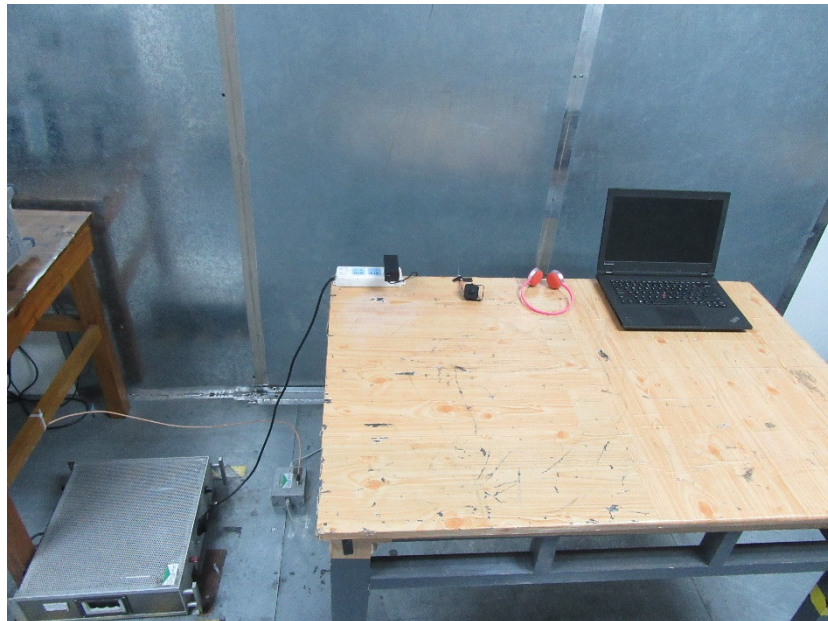
1. The EUT working normal, before the conditioning.
2. Monitor the EUT during the conditioning period and detected no any changes in states, during the conditioning.
3. No degradation in the performance of the EUT was observed, after the conditioning.

## 8 Photographs

### 8.1 Conducted Emissions at Mains Terminals (150kHz-30MHz) Test Setup



### 8.2 Asymmetric Mode Conducted Emissions (150kHz-30MHz) Test Setup





### 8.3 Radiated Emissions (30MHz-1GHz) Test Setup



### 8.4 Radiated Emissions (above 1GHz) Test Setup



## 8.5 Voltage Fluctuations and Flicker Test Setup



## 8.6 Electrostatic Discharge Test Setup





## 8.7 Radiated Immunity (80MHz-1GHz) Test Setup



## 8.8 Radiated Immunity(80MHz-2.7GHz) Test Setup



## 8.9 Electrical Fast Transients/Burst at Power Port Test Setup



## 8.10 Electrical Fast Transients/Burst at Signal Port Test Setup





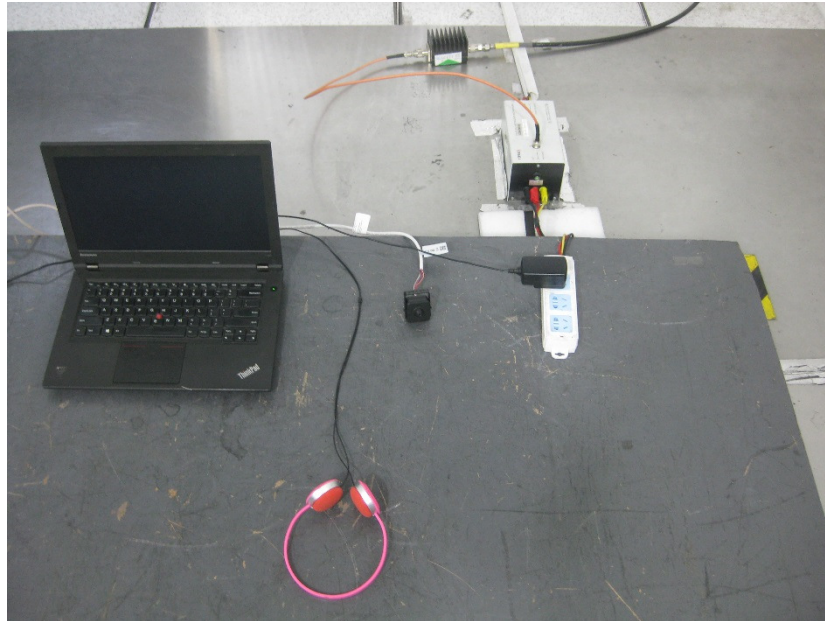
### 8.11 Surge at Power Port Test Setup



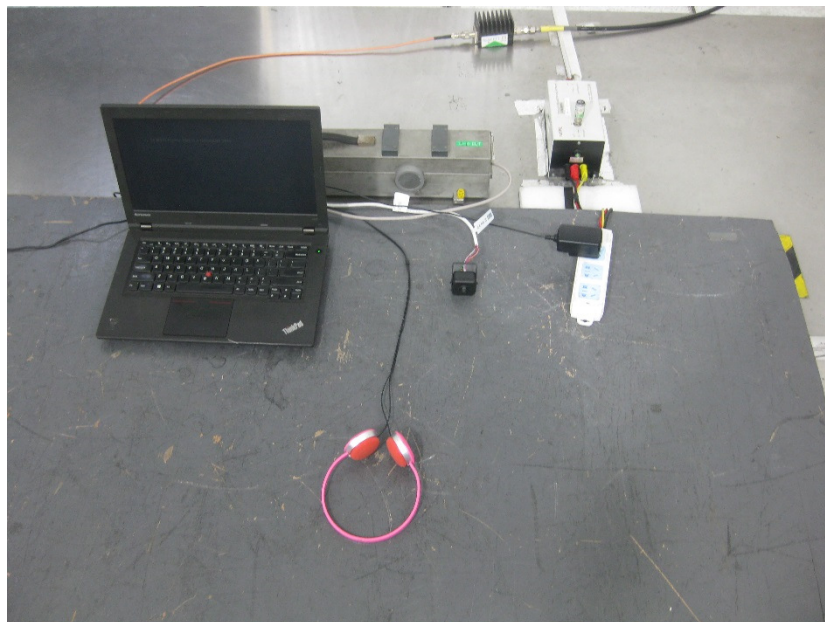
### 8.12 Surge at Signal Port Test Setup



### 8.13 Conducted Immunity at Power Port (150kHz-80MHz) Test Setup

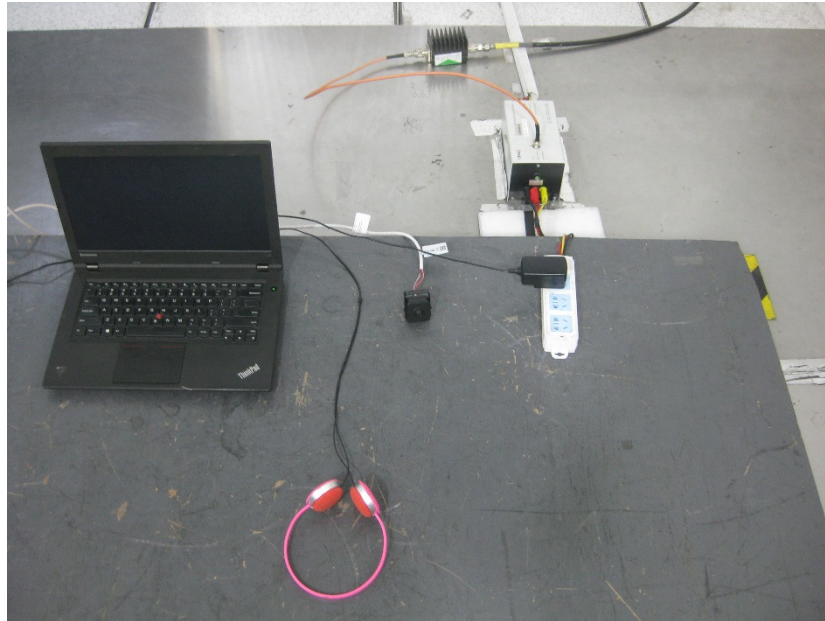


### 8.14 Conducted Immunity at Signal Port (150kHz-80MHz) Test Setup

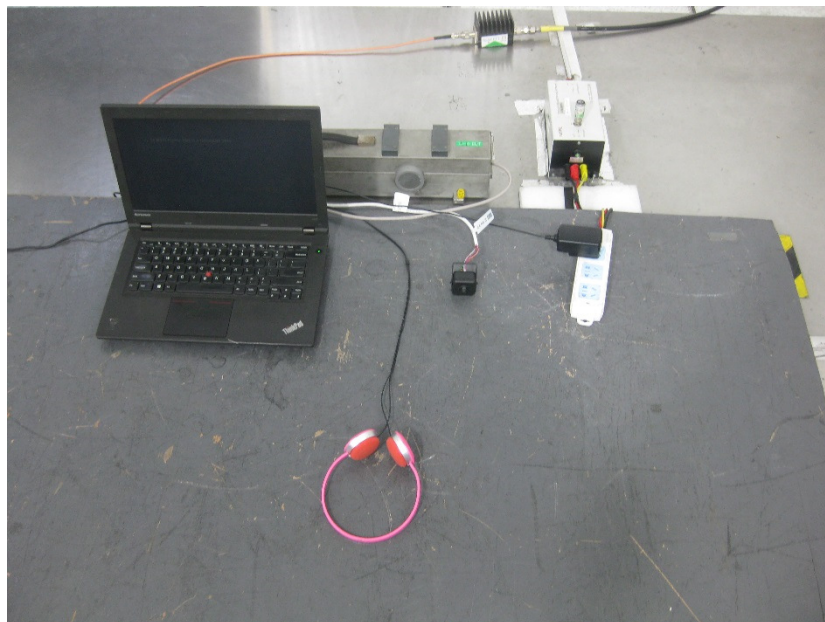




### 8.15 Conducted Immunity at Power Port (150kHz-100MHz) Test Setup



### 8.16 Conducted Immunity at Signal Port (150kHz-100MHz) Test Setup



### 8.17 Voltage Dips and Interruptions Test Setup

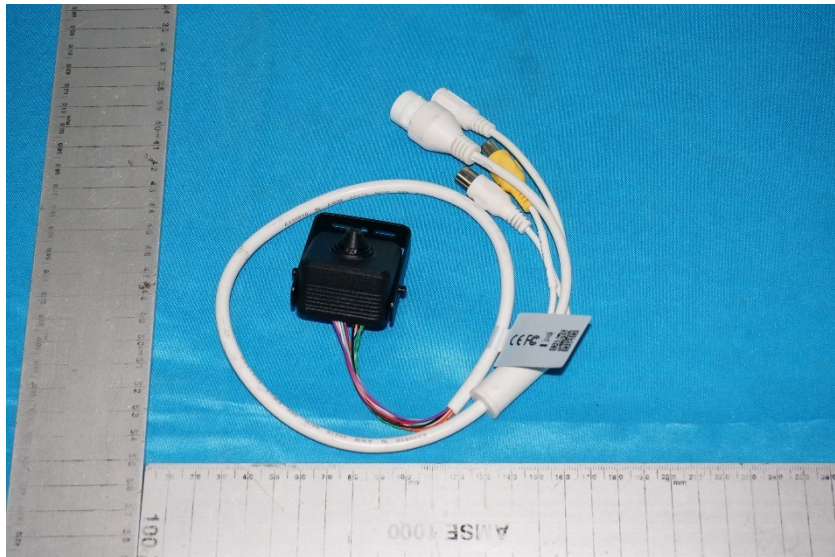


### 8.18 Mains Supply Voltage Variations-Conditioning Test Setup

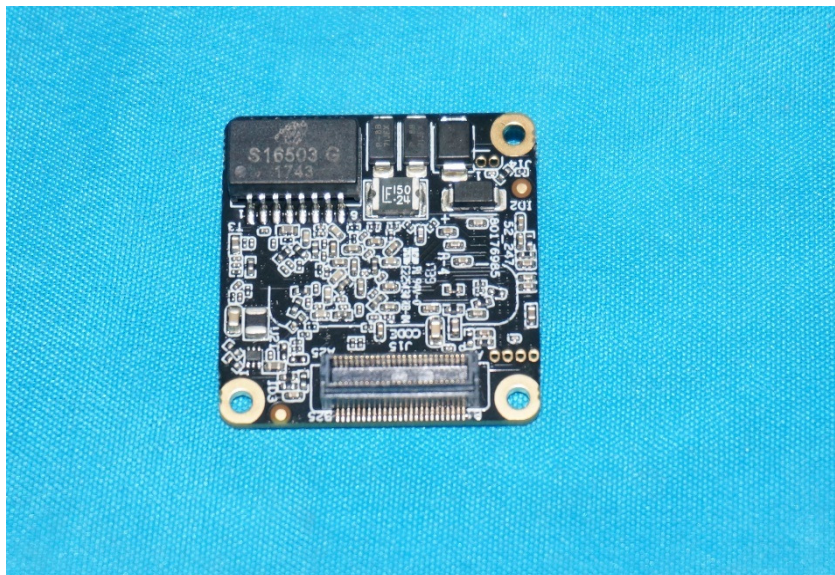
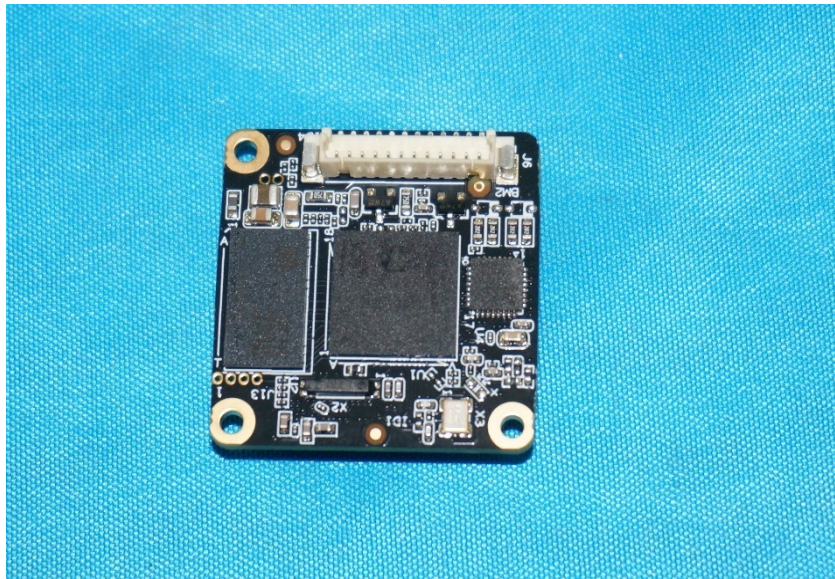


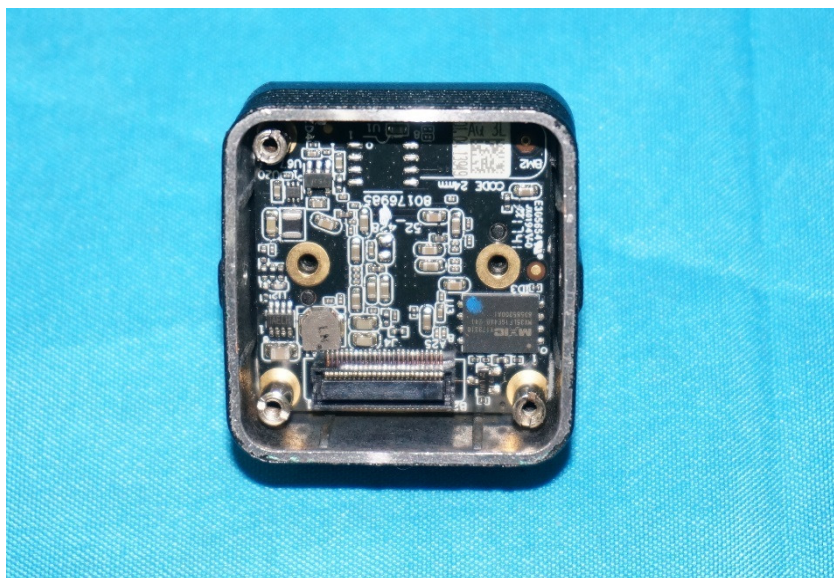


### 8.19 EUT Constructional Details (EUT Photos)









- End of the Report -